TS3A5018 10Ω 四通道 SPDT 模拟开关

1 特性

- 低通态电阻 (10Ω)
- 低电荷注入
- 出色的通态电阻匹配
- 低总谐波失真 (THD)
- 1.8V 至 3.6V 单电源运行
- 闩锁性能超出 JESD 78 II 类规范要求的 100mA
- 静电放电 (ESD) 性能测试符合 JESD 22 标准
  - 2000V 人体放电模型 （A114-B，II 类）
  - 1000V 充电器件模型 (C101)

2 应用

- 采样和保持电路
- 电池供电类设备
- 音频和视频信号路由
- 通信电路

3 说明

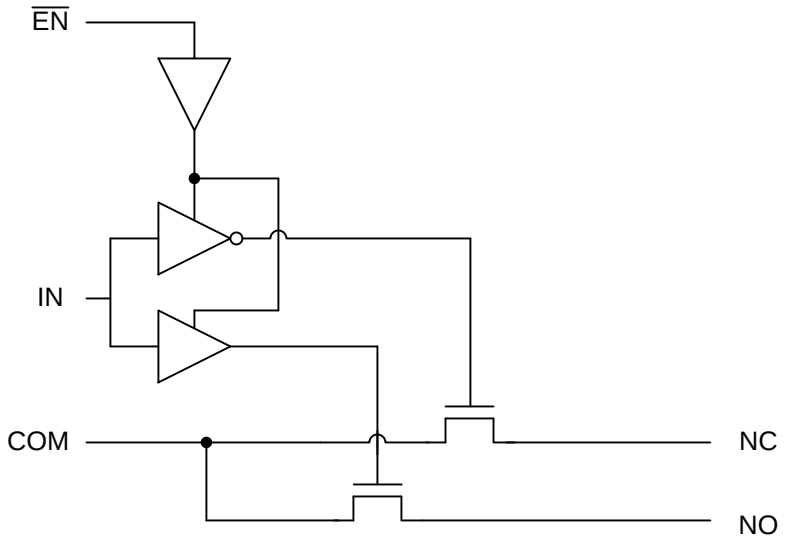
TS3A5018 器件是一款四通道单极双投 (SPDT) 模拟开关，其设计工作电压为 1.8V 至 3.6V。此器件可以处理数据和模拟信号，并且高达 V_+ 的信号在任一方向上传输。

器件信息(1)

器件型号	封装	封装尺寸（标称值）
TS3A5018	SOIC (16)	9.90mm × 6.00mm
	SSOP (16)	6.00mm × 4.90mm
	TSSOP (16)	5.00mm × 4.40mm
	TVSOP (16)	4.40mm × 3.60mm
	UQFN (16)	2.50mm × 1.80mm
	VQFN (16)	4.00mm × 3.50mm

(1) 如需了解所有可用封装，请参阅数据表末尾的可订购产品附录。

方框图



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4 修订历史记录

注：之前版本的页码可能与当前版本有所不同。

Changes from Revision G (March 2015) to Revision H **Page**

- Changed the pinout images ... 3
- Changed the r_{on} MAX value at 25°C From: 8 Ω To: 17 Ω in the *Electrical Characteristics for 1.8-V Supply* table ... 7
- Changed the r_{on} MAX value at Full From: 14.55 Ω To: 32 Ω in the *Electrical Characteristics for 1.8-V Supply* table ... 7

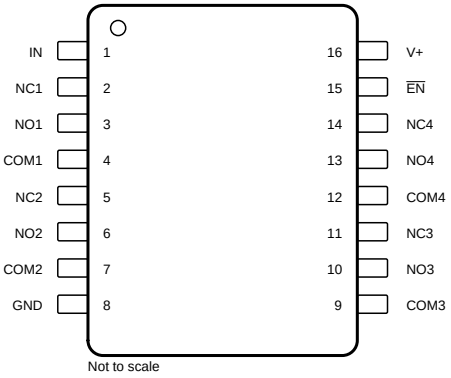
Changes from Revision F (June 2013) to Revision G **Page**

- 添加了*应用*、*器件信息* 表、*引脚功能* 表、*ESD 额定值* 表、*热性能信息* 表、*典型特性*、*特性 说明* 部分、*器件功能模式*、*应用和实施* 部分、*电源建议* 部分、*布局* 部分、*器件和文档支持* 部分以及*机械、封装和可订购信息* 部分。 ... 1
- 已删除 *订购信息* 表。 ... 1

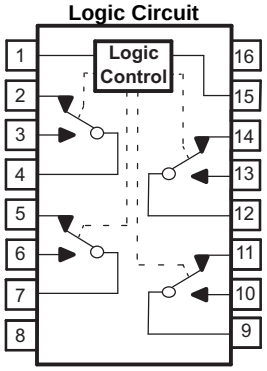
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5 Pin Configuration and Functions

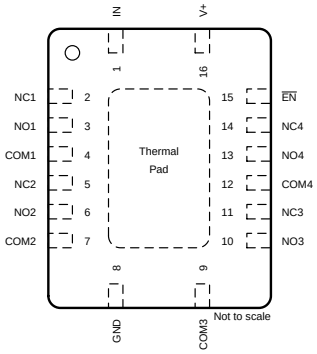
D, DBQ, DGV and PW Package
16-Pin SOIC, SSOP, TVSOP and TSSOP
(Top View)



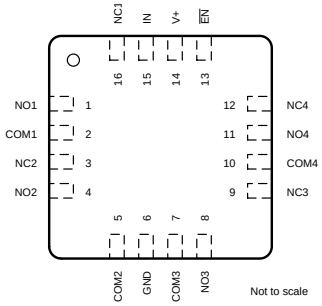
Logic Circuit



RGY Package
16-Pin VQFN
(Top View)



RSV Package
16-Pin UQFN
(Top View)



Pin Functions

PIN			TYPE	DESCRIPTION
NAME	SOIC, SSOP, TVSOP, VQFN NO.	UQFN NO.		
COM1	4	2	I/O	Common path for switch
COM2	7	5	I/O	Common path for switch
COM3	9	7	I/O	Common path for switch
COM4	12	10	I/O	Common path for switch
$\overline{EN}$	15	13	I	Active-low switch enable input
GND	8	6	—	Ground
IN	1	15	I	Switch path selector input
NC1	2	16	I/O	Normally closed path for switch
NC2	5	3	I/O	Normally closed path for switch
NC3	11	9	I/O	Normally closed path for switch
NC4	14	12	I/O	Normally closed path for switch
NO1	3	1	I/O	Normally open path for switch
NO2	6	4	I/O	Normally open path for switch
NO3	10	8	I/O	Normally open path for switch
NO4	13	11	I/O	Normally open path for switch
V+	16	14	—	Supply voltage

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6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)(2)

			MIN	MAX	UNIT
V_+	Supply voltage(3)		–0.5	4.6	V
V_{NC} V_{NO} V_{COM}	Analog voltage(3)(4)		–0.5	4.6	V
I_K	Analog port diode current	V_{NC}, V_{NO}, V_{COM} < 0	–50		mA
I_{NC} I_{NO} I_{COM}	ON-state switch current	V_{NC}, V_{NO}, V_{COM} = 0 to 7 V	–64	64	mA
V_I	Digital input voltage(3)(4)		–0.5	4.6	V
I_{IK}	Digital input clamp current	V_I < 0	–50		mA
I_+	Continuous current through V_+		–100	100	mA
I_{GND}	Continuous current through GND		–100	100	mA
T_{stg}	Storage temperature		–65	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum
(3) All voltages are with respect to ground, unless otherwise specified.
(4) The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001(1)	±2000	V
		Charged-device model (CDM), per JEDEC specification JESD22-C101(2)	±1000	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
$V_{I/O}$	Switch input and output voltage	0	V_+	V
V_+	Supply voltage	1.65	3.6	V
V_I	Control input voltage	0	3.6	V
T_A	Operating temperature	-40	85	°C

6.4 Thermal Information

THERMAL METRIC(1)		TS3A5018						UNIT
		D (SOIC)	DBQ (SSOP)	DGV (TVSOP)	PW (TSSOP)	RGY (VQFN)	RSV (UQFN)	
		16 PINS	16 PINS	16 PINS	16 PINS	16 PINS	16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	73	90	120	108	51	184	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report.

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6.5 Electrical Characteristics for 3.3-V Supply

V_+ = 3 V to 3.6 V, T_A = –40°C to 85°C (unless otherwise noted)(1)

PARAMETER		TEST CONDITIONS		T_A	V_+	MIN	TYP	MAX	UNIT
Analog Switch									
V_{COM}, V_{NO}, V_{NC}	Analog signal range					0		V_+	V
r_{on}	ON-state resistance	0 ≤ (V_{NC} or V_{NO}) ≤ V_+, I_{COM} = –32 mA,	Switch ON, see Figure 17	25°C	3 V		7	10	Ω
				Full				12	
Δr_{on}	ON-state resistance match between channels	V_{NC} or V_{NO} = 2.1 V, I_{COM} = –32 mA,	Switch ON, see Figure 17	25°C	3 V		0.3	0.8	Ω
				Full				1	
$r_{on(flat)}$	ON-state resistance flatness	0 ≤ (V_{NC} or V_{NO}) ≤ V_+, I_{COM} = –32 mA,	Switch ON, see Figure 17	25°C	3 V		5	7	Ω
				Full				8	
$I_{NC(OFF)}$, $I_{NO(OFF)}$	NC, NO OFF leakage current	V_{NC} or V_{NO} = 1 V, V_{COM} = 3 V, or V_{NC} or V_{NO} = 3 V, V_{COM} = 1 V,	Switch OFF, see Figure 18	25°C	3.6 V	–0.1	0.05	0.1	µA
				Full		–0.2		0.2	
		V_{NC} or V_{NO} = 0 to 3.6 V, V_{COM} = 3.6 V to 0, or V_{NC} or V_{NO} = 3.6 V to 0, V_{COM} = 0 to 3.6 V,	Switch OFF, see Figure 18	25°C	0 V	–2	0.05	2	
				Full		–10		10	
$I_{COM(OFF)}$	COM OFF leakage current	V_{COM} = 1 V, V_{NC} or V_{NO} = 3 V, or V_{COM} = 3 V, V_{NC} or V_{NO} = 3 V,	Switch OFF, see Figure 18	25°C	3.6 V	–0.1	0.05	0.1	µA
				Full		–0.2		0.2	
		V_{COM} = 0 to 3.6 V, V_{NC} or V_{NO} = 3.6 V to 0, or V_{COM} = 3.6 V to 0, V_{NC} or V_{NO} = 0 to 3.6 V,	Switch OFF, see Figure 18	25°C	0 V	–2	0.05	2	
				Full		–10		10	
$I_{NC(ON)}$, $I_{NO(ON)}$	NC, NO ON leakage current	V_{NC} or V_{NO} = 1 V, V_{COM} = Open, or V_{NC} or V_{NO} = 3 V, V_{COM} = Open,	Switch ON, see Figure 19	25°C	3.6 V	–0.1	0.05	0.1	µA
				Full		–0.2		0.2	
$I_{COM(ON)}$	COM ON leakage current	V_{COM} = 1 V, V_{NC} or V_{NO} = Open, or V_{COM} = 3 V, V_{NC} or V_{NO} = Open,	Switch ON, see Figure 19	25°C	3.6 V	–0.1	0.05	0.1	µA
				Full		–0.2		0.2	
V_{IH}	Input logic high			Full		2		V_+	V
V_{IL}	Input logic low			Full		0		0.8	V
I_{IH}, I_{IL}	Input leakage current	V_I = V_+ or 0		25°C	3.6 V	–1	0.05	1	µA
				Full		–1		1	
Q_C	Charge injection	V_{GEN} = 0, R_{GEN} = 0,	C_L = 0.1 nF, see Figure 26	25°C	3.3 V		2		pC
$C_{NC(OFF)}$, $C_{NO(OFF)}$	NC, NO OFF capacitance	V_{NC} or V_{NO} = V_+ or GND,	Switch OFF, see Figure 20	25°C	3.3 V		4.5		pF
$C_{COM(OFF)}$	COM OFF capacitance	V_{COM} = V_+ or GND,	Switch OFF, see Figure 20	25°C	3.3 V		9		pF
$C_{NC(ON)}$, $C_{NO(ON)}$	NC, NO ON capacitance	V_{NC} or V_{NO} = V_+ or GND,	Switch ON, see Figure 20	25°C	3.3 V		16		pF
$C_{COM(ON)}$	COM ON capacitance	V_{COM} = V_+ or GND,	Switch ON, see Figure 20	25°C	3.3 V		16		pF

(1) The algebraic convention is used in this data sheet; the most negative value is shown in the minimum column.

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Electrical Characteristics for 3.3-V Supply (continued)

V_+ = 3 V to 3.6 V, T_A = –40°C to 85°C (unless otherwise noted)(1)

PARAMETER		TEST CONDITIONS		T_A	V_+	MIN	TYP	MAX	UNIT
C_I	Digital input capacitance	V_I = V_+ or GND,	See Figure 20	25°C	3.3 V		3		pF
BW	Bandwidth	R_L = 50 Ω,	Switch ON, see Figure 22	25°C	3.3 V		300		MHz
O_{ISO}	OFF isolation	R_L = 50 Ω, f = 10 MHz,	Switch OFF, see Figure 23	25°C	3.3 V		–48		dB
X_{TALK}	Crosstalk	R_L = 50 Ω, f = 10 MHz,	Switch ON, see Figure 24	25°C	3.3 V		–48		dB
$X_{TALK(ADJ)}$	Crosstalk adjacent	R_L = 50 Ω, f = 10 MHz,	Switch ON, see Figure 25	25°C	3.3 V		–81		dB
THD	Total harmonic distortion	R_L = 600 Ω, C_L = 50 pF,	f = 20 Hz to 20 kHz, see Figure 27	25°C	3.3 V		0.21%		
I_+	Positive supply current	V_I = V_+ or GND,	Switch ON or OFF	25°C	3.6 V		2.5	7	µA
				Full				10	

6.6 Electrical Characteristics for 2.5-V Supply

V_+ = 2.3 V to 2.7 V, T_A = –40°C to 85°C (unless otherwise noted)(1)

PARAMETER		TEST CONDITIONS		T_A	V_+	MIN	TYP	MAX	UNIT
V_{COM}, V_{NC}, V_{NO}	Analog signal range					0		V_+	V
r_{on}	ON-state resistance	0 ≤ (V_{NC} or V_{NO}) ≤ V_+, I_{COM} = –24 mA,	Switch ON, see Figure 17	25°C	2.3 V		12	20	Ω
				Full				22	
Δr_{on}	ON-state resistance match between channels	V_{NC} or V_{NO} = 1.6 V, I_{COM} = –24 mA,	Switch ON, see Figure 17	25°C	2.3 V		0.3	1	Ω
				Full				2	
$r_{on(flat)}$	ON-state resistance flatness	0 ≤ (V_{NC} or V_{NO}) ≤ V_+, I_{COM} = –24 mA,	Switch ON, see Figure 17	25°C	2.3 V		14	18	Ω
				Full				20	
$I_{NC(OFF)}$, $I_{NO(OFF)}$	NC, NO OFF leakage current	V_{NC} or V_{NO} = 0.5 V, V_{COM} = 2.2 V, or V_{NC} or V_{NO} = 2.2 V, V_{COM} = 0.5 V,	Switch OFF, see Figure 18	25°C	2.7 V	–0.1	0.05	0.1	µA
				Full		–0.2		0.2	
		V_{NC} or V_{NO} = 0 to 3.6 V, V_{COM} = 3.6 V to 0, or V_{NC} or V_{NO} = 3.6 V to 0, V_{COM} = 0 to 3.6 V,	Switch OFF, see Figure 18	25°C	0 V	–2	0.05	2	
				Full		–10		10	
$I_{COM(OFF)}$	COM OFF leakage current	V_{COM} = 0.5 V, V_{NC} or V_{NO} = 2.2 V, or V_{COM} = 2.2 V, V_{NC} or V_{NO} = 0.5 V,	Switch OFF, see Figure 18	25°C	2.7 V	–0.1	0.05	0.1	µA
				Full		–0.2		0.2	
		V_{COM} = 0 to 3.6 V, V_{NC} or V_{NO} = 3.6 V to 0, or V_{COM} = 3.6 V to 0, V_{NC} or V_{NO} = 0 to 3.6 V,	Switch OFF, see Figure 18	25°C	0 V	–2	0.05	2	
				Full		–10		10	
$I_{NC(ON)}$, $I_{NO(ON)}$	NC, NO ON leakage current	V_{NC} or V_{NO} = 0.5 V, V_{COM} = Open, or V_{NC} or V_{NO} = 2.2 V, V_{COM} = Open,	Switch ON, see Figure 19	25°C	2.7 V	–0.1	0.05	0.1	µA
				Full		–0.2		0.2	
$I_{COM(ON)}$	COM ON leakage current	V_{COM} = 0.5 V, V_{NC} or V_{NO} = Open, or V_{COM} = 2.2 V, V_{NC} or V_{NO} = Open,	Switch ON, see Figure 19	25°C	2.7 V	–0.1	0.05	0.1	µA
				Full		–0.2		0.2	
V_{IH}	Input logic high			Full		1.7		V_+	V
V_{IL}	Input logic low			Full		0		0.7	V

(1) The algebraic convention is used in this data sheet; the most negative value is shown in the minimum column.

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Electrical Characteristics for 2.5-V Supply (continued)

V_+ = 2.3 V to 2.7 V, T_A = –40°C to 85°C (unless otherwise noted)(1)

PARAMETER		TEST CONDITIONS		T_A	V_+	MIN	TYP	MAX	UNIT
I_{IH}, I_{IL}	Input leakage current	V_I = V_+ or 0		25°C	2.7 V	–0.1	0.05	0.1	µA
				Full		–1		1	
Q_C	Charge injection	V_{GEN} = 0, R_{GEN} = 0,	C_L = 0.1 nF, see Figure 26	25°C	2.5 V		1		pC
$C_{NC(OFF)}$, $C_{NO(OFF)}$	NC, NO OFF capacitance	V_{NC} or V_{NO} = V_+ or GND,	Switch OFF, see Figure 20	25°C	2.5 V		3		pF
$C_{COM(OFF)}$	COM OFF capacitance	V_{COM} = V_+ or GND,	Switch OFF, see Figure 20	25°C	2.5 V		9		pF
$C_{NC(ON)}$, $C_{NO(ON)}$	NC, NO ON capacitance	V_{NC} or V_{NO} = V_+ or GND,	Switch ON, see Figure 20	25°C	2.5 V		16		pF
$C_{COM(ON)}$	COM ON capacitance	V_{COM} = V_+ or GND,	Switch ON, see Figure 20	25°C	2.5 V		16		pF
C_I	Digital input capacitance	V_I = V_+ or GND,	See Figure 20	25°C	2.5 V		3		pF
BW	Bandwidth	R_L = 50 Ω,	Switch ON, see Figure 22	25°C	2.5 V		300		MHz
O_{ISO}	OFF isolation	R_L = 50 Ω, f = 10 MHz,	Switch OFF, see Figure 23	25°C	2.5 V		–48		dB
X_{TALK}	Crosstalk	R_L = 50 Ω, f = 10 MHz,	Switch ON, see Figure 24	25°C	2.5 V		–48		dB
$X_{TALK(ADJ)}$	Crosstalk adjacent	R_L = 50 Ω, f = 10 MHz,	Switch ON, see Figure 25	25°C	3.3 V		–81		dB
THD	Total harmonic distortion	R_L = 600 Ω, C_L = 50 pF,	f = 20 Hz to 20 kHz, see Figure 27	25°C	2.5 V		0.33%		
I_+	Positive supply current	V_I = V_+ or GND,	Switch ON or OFF	25°C	2.7 V		2.5	7	µA
				Full				10	

6.7 Electrical Characteristics for 2.1-V Supply

V_+ = 2.00 V to 2.20 V, T_A = –40°C to 85°C (unless otherwise noted)(1)

PARAMETER		TEST CONDITIONS	T_A	V_+	MIN	TYP	MAX	UNIT
V_{IH}	Input logic high		Full		1.2		4.3	V
V_{IL}	Input logic low		Full		0		0.5	V

(1) The algebraic convention is used in this data sheet; the most negative value is shown in the minimum column.

6.8 Electrical Characteristics for 1.8-V Supply

V_+ = 1.65 V to 1.95 V, T_A = –40°C to 85°C (unless otherwise noted)(1)

PARAMETER		TEST CONDITIONS		T_A	V_+	MIN	TYP	MAX	UNIT
V_{COM}, V_{NC}, V_{NO}	Analog signal range					0		V_+	V
r_{on}	ON-state resistance	0 ≤ (V_{NC} or V_{NO}) ≤ V_+, I_{COM} = –32 mA,	Switch ON, see Figure 17	25°C	1.65 V		5.5	17	Ω
				Full				32	
Δr_{on}	ON-state resistance match between channels	V_{NC} or V_{NO} = 1.5 V, I_{COM} = –32 mA,	Switch ON, see Figure 17	25°C	1.65 V		0.3	1	Ω
				Full				1.2	
$r_{on(flat)}$	ON-state resistance flatness	0 ≤ (V_{NC} or V_{NO}) ≤ V_+, I_{COM} = –32 mA,	Switch ON, see Figure 17	25°C	1.65 V		2.7	5.5	Ω
				Full				7.3	

(1) The algebraic convention is used in this data sheet; the most negative value is shown in the minimum column.

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Electrical Characteristics for 1.8-V Supply (continued)

V_+ = 1.65 V to 1.95 V, T_A = –40°C to 85°C (unless otherwise noted)(1)

PARAMETER		TEST CONDITIONS		T_A	V_+	MIN	TYP	MAX	UNIT
$I_{NC(OFF)}$, $I_{NO(OFF)}$	NC, NO OFF leakage current	V_{NC} or V_{NO} = 0.3 V, V_{COM} = 1.65V, or V_{NC} or V_{NO} = 1.65V, V_{COM} = 0.3 V,	Switch OFF, see Figure 18	25°C	1.95 V	–0.25	0.03	0.25	µA
				Full		–4.5		4.5	
		V_{NC} or V_{NO} = 1.95 V to 0 V, V_{COM} = 0 V to 1.95 V, or V_{NC} or V_{NO} = 0 V to 1.95 V, V_{COM} = 1.95 V to 0 V,	Switch OFF, see Figure 18	25°C	0 V	–0.4	0.01	0.4	
				Full		–6.5		6.5	
$I_{COM(OFF)}$	COM OFF leakage current	V_{COM} = 1.65 V, V_{NC} or V_{NO} = 0.3V, or V_{COM} = 0.3 V, V_{NC} or V_{NO} = 1.65V,	Switch OFF, see Figure 18	25°C	1.95 V	–0.4	0.02	0.4	µA
				Full		–0.9		0.9	
		V_{COM} = 0 V to 1.95 V, V_{NC} or V_{NO} = 1.95 V to 0 V, or V_{COM} = 1.95 V to 0, V_{NC} or V_{NO} = 0 to 1.95 V,	Switch OFF, see Figure 18	25°C	0 V	–0.4	0.02	0.4	
				Full		–4.5		4.5	
$I_{NC(ON)}$, $I_{NO(ON)}$	NC, NO ON leakage current	V_{NC} or V_{NO} = 0.3 V, V_{COM} = Open, or V_{NC} or V_{NO} = 1.65 V, V_{COM} = Open,	Switch ON, see Figure 19	25°C	1.95 V	–2.	0.02	2	µA
				Full		–2	0.02	2	
$I_{COM(ON)}$	COM ON leakage current	V_{COM} = 0.3 V, V_{NC} or V_{NO} = Open, or V_{COM} = 1.65 V, V_{NC} or V_{NO} = Open,	Switch ON, see Figure 19	25°C	1.95 V	–4.5		4.5	µA
				Full					
V_{IH}	Input logic high	V_I = V_+ or GND		Full	1.95 V	1		3.6	V
V_{IL}	Input logic low			Full	1.95 V	0		0.4	V
I_{IH}, I_{IL}	Input leakage current	V_I = V_+ or 0		25°C	1.95 V	–0.1	0.01	0.1	µA
				Full		–2.1		2.1	

6.9 Switching Characteristics for 3.3-V Supply

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T_A	V_+	MIN	TYP	MAX	UNIT
t_{ON}	Turnon time	V_{COM} = 2 V, R_L = 300 Ω,	C_L = 35 pF, see Figure 21	25°C	3.3 V	2.5	3.5	8	ns
				Full	3 V to 3.6 V	2.5		9	
t_{OFF}	Turnoff time	V_{COM} =2 V, R_L = 300 Ω,	C_L = 35 pF, see Figure 21	25°C	3.3 V	0.5	2	6.5	ns
				Full	3 V to 3.6 V	0.5		7	

6.10 Switching Characteristics for 2.5-V Supply

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T_A	V_+	MIN	TYP	MAX	UNIT
t_{ON}	Turnon time	V_{COM} = 1.5 V, R_L = 300 Ω,	C_L = 35 pF, see Figure 21	25°C	2.5 V	2.5	5	9.5	ns
				Full	2.3 V to 2.7 V	2.5		10.5	
t_{OFF}	Turnoff time	V_{COM} =1.5 V, R_L = 300 Ω,	C_L = 35 pF, see Figure 21	25°C	2.5 V	0.5	3	7.5	ns
				Full	2.3 V to 2.7 V	0.5		9	

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6.11 Switching Characteristics for 1.8-V Supply

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T_A	V_+	MIN	TYP	MAX	UNIT
t_{ON}	Turnon time	$V_{COM} = V_+$, $R_L = 50\ \Omega$,	$C_L = 35$ pF, see Figure 21	25°C	1.8 V		14.1	49.3	ns
				Full	1.65 V to 1.95 V		49.3	56.7	
t_{OFF}	Turnoff time	$V_{COM} = V_+$, $R_L = 50\ \Omega$,	$C_L = 35$ pF, see Figure 21	25°C	1.8 V		16.1	26.5	ns
				Full	1.65 V to 1.95 V			31.2	
t_{BBM}	Break-before-make time	$V_{NC} = V_{NO} = V_+/2$, $R_L = 50\ \Omega$,	$C_L = 35$ pF, see Figure 21	25°C	1.8 V	5.3	18.4	58	ns
				Full	1.65 V to 1.95 V			58	

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6.12 Typical Characteristics

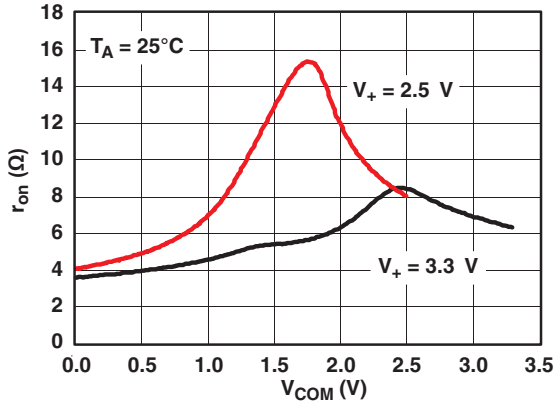


Figure 1. r_{on} vs V_{COM} (V_+ = 3.3 V)

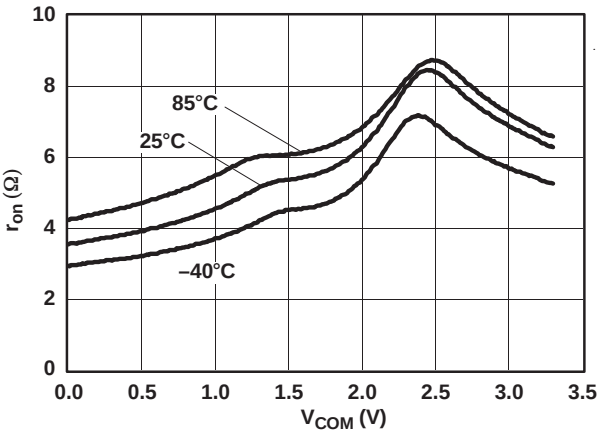


Figure 2. r_{on} vs V_{COM} (V_+ = 2.5 V)

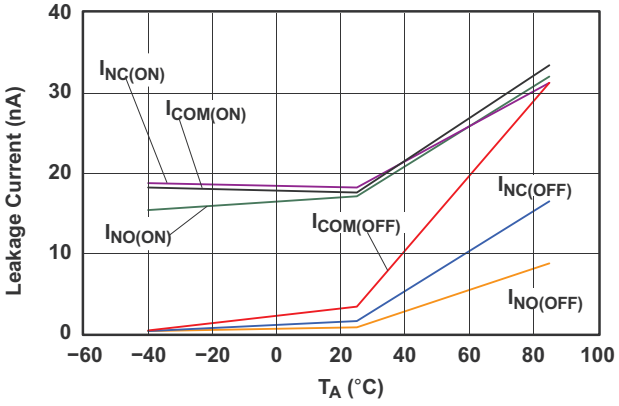


Figure 3. Leakage Current vs Temperature (V_+ = 3.6 V)

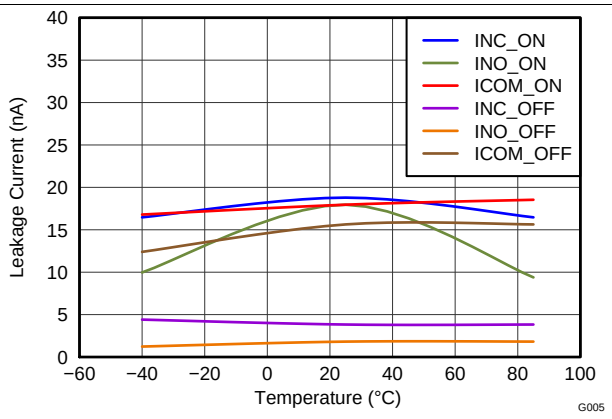


Figure 4. Leakage Current vs Temperature (V_+ = 1.8 V)

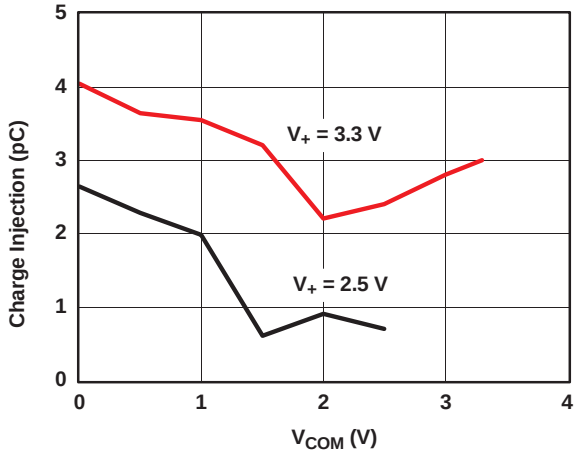


Figure 5. Charge Injection (Q_C) vs V_{COM}

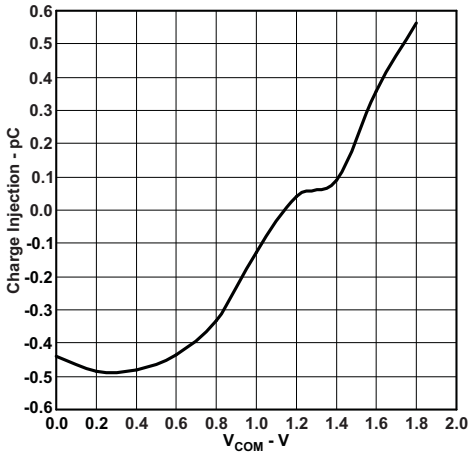


Figure 6. Charge Injection (Q_C) vs V_{COM} (V_+ = 1.8 V)

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Typical Characteristics (continued)

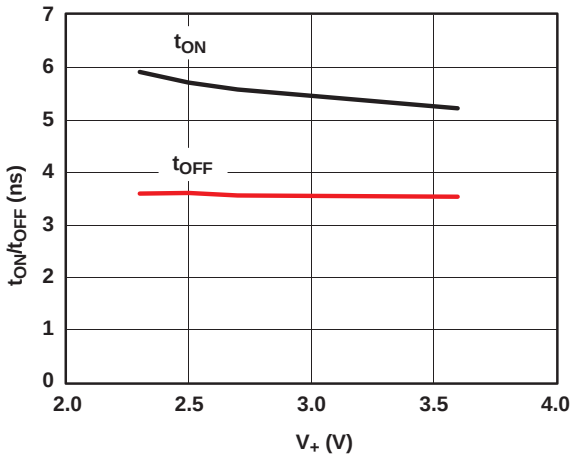


Figure 7. t_{ON} and t_{OFF} vs Supply Voltage

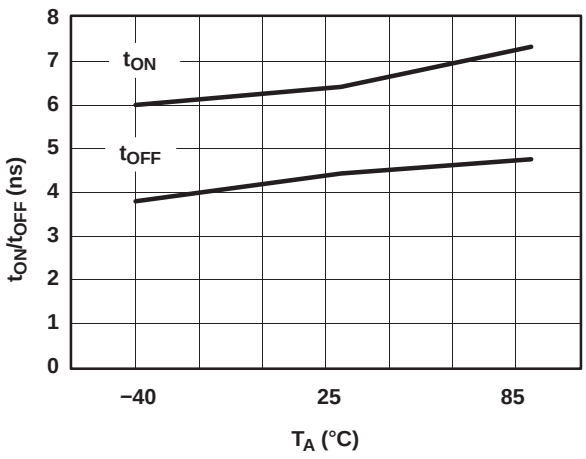


Figure 8. t_{ON} and t_{OFF} vs Temperature (V_+ = 3.3 V)

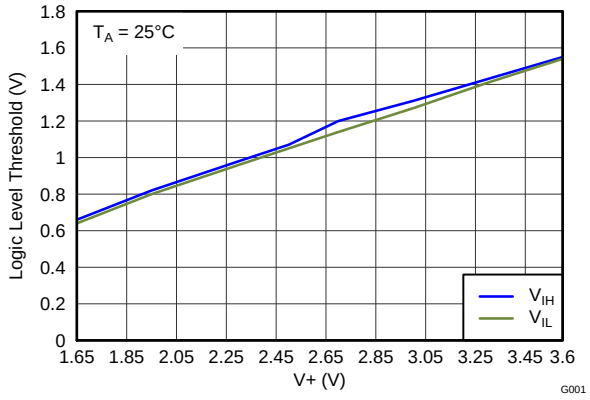


Figure 9. Logic-Level Threshold vs V_+

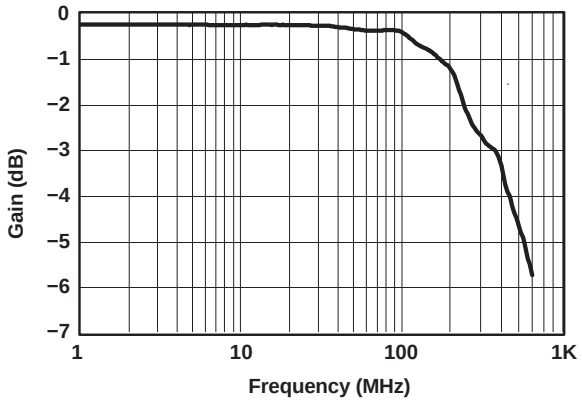


Figure 10. Gain vs Frequency Bandwidth (V_+ = 3.3 V)

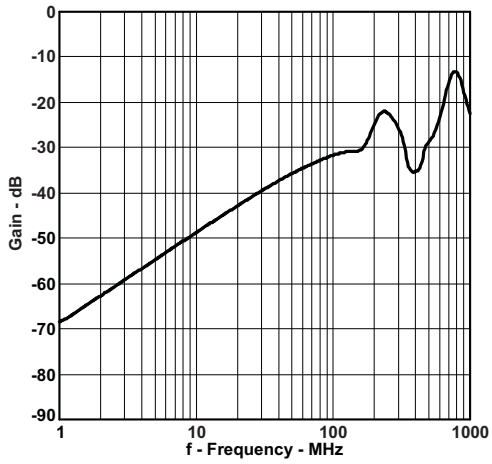


Figure 11. OFF Isolation vs Frequency (V_+ = 1.8 V)

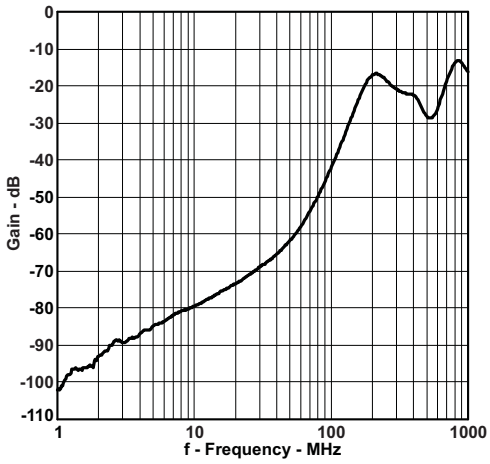


Figure 12. Crosstalk Adjacent vs Frequency (V_+ = 1.8 V)

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Typical Characteristics (continued)

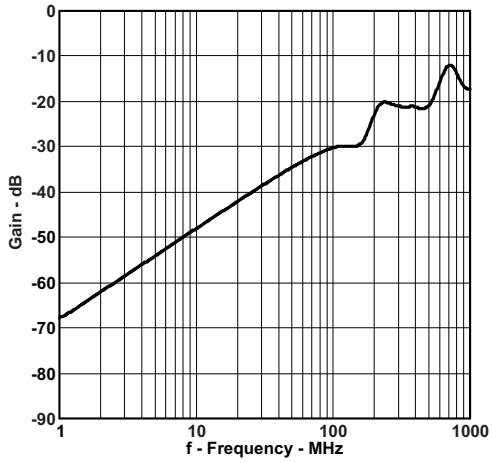


Figure 13. Crosstalk vs Frequency (V_+ = 1.8 V)

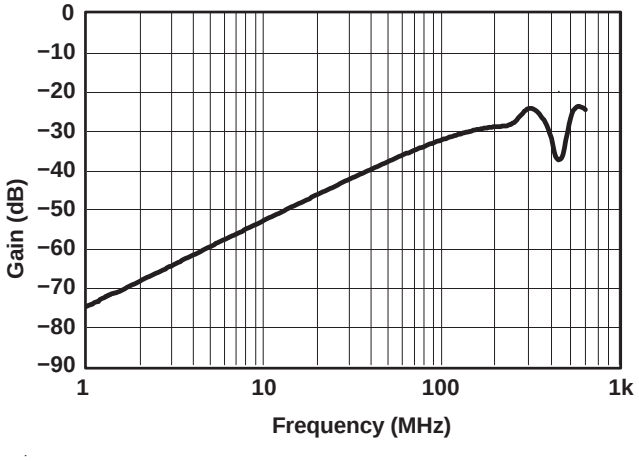


Figure 14. OFF Isolation vs Frequency (V_+ = 3.3 V)

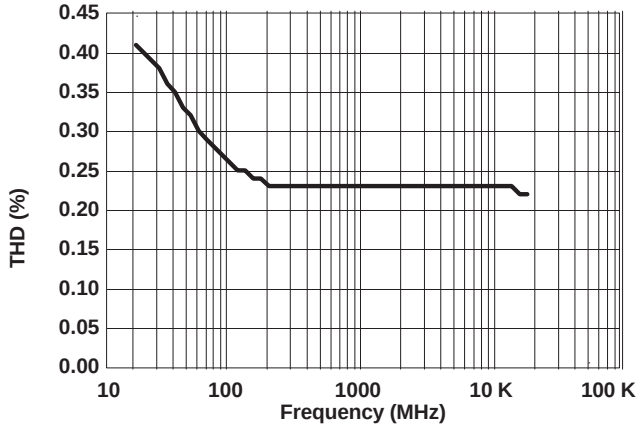


Figure 15. Total Harmonic Distortion vs Frequency

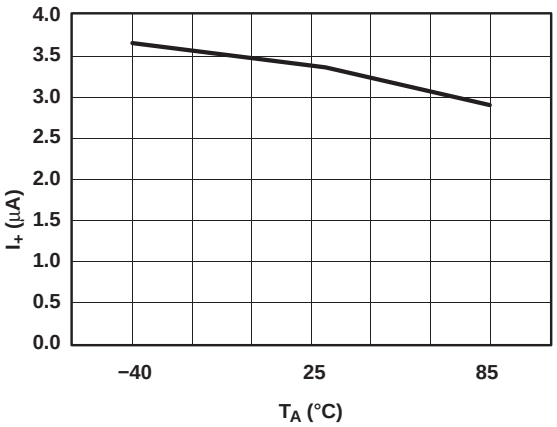


Figure 16. Power-Supply Current vs Temperature (V_+ = 3.3 V)

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7 Parameter Measurement Information

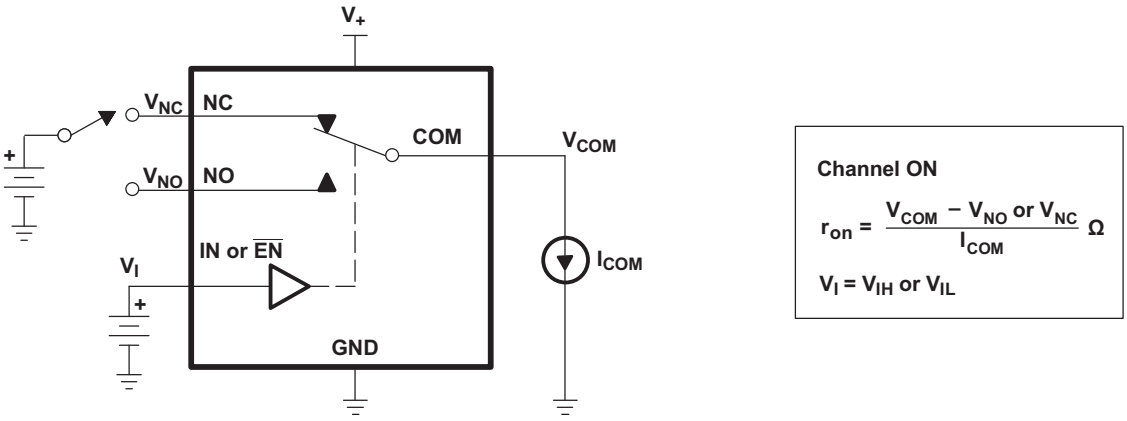


Figure 17. ON-State Resistance (r_{on})

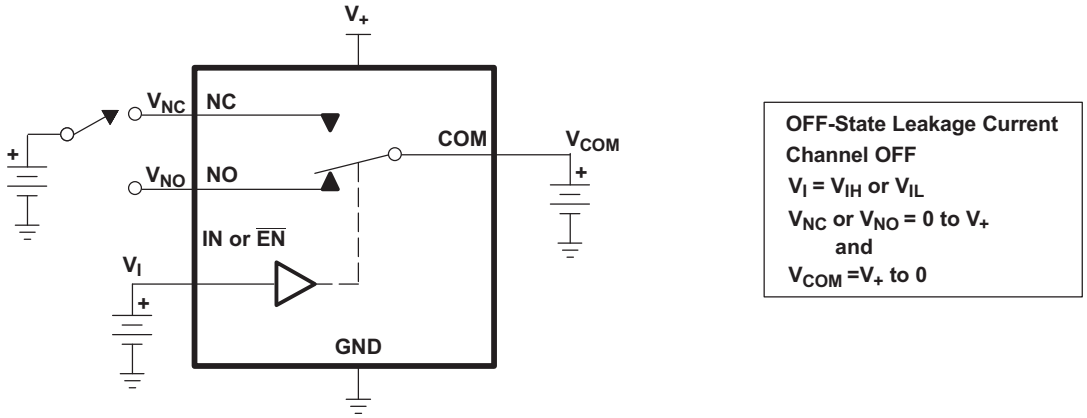


Figure 18. OFF-State Leakage Current ($I_{COM(OFF)}$, $I_{NC(OFF)}$, $I_{NO(OFF)}$)

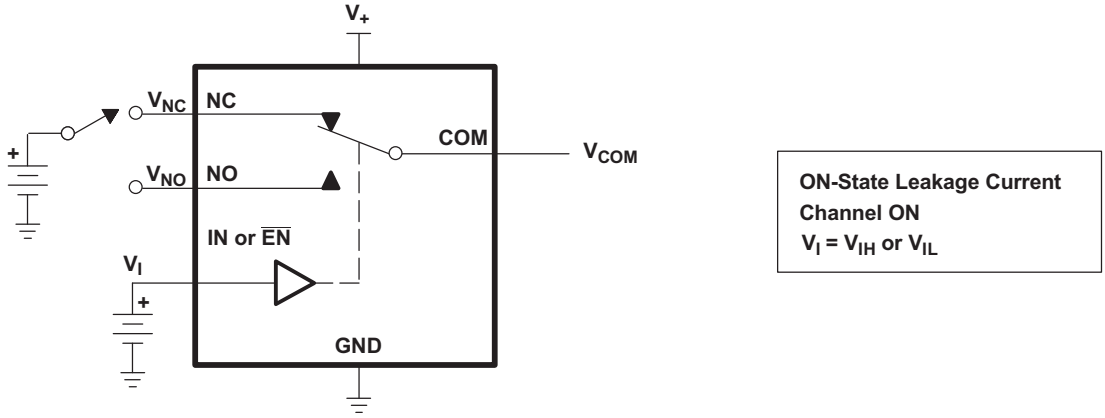


Figure 19. ON-State Leakage Current ($I_{COM(ON)}$, $I_{NC(ON)}$)

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Parameter Measurement Information (continued)

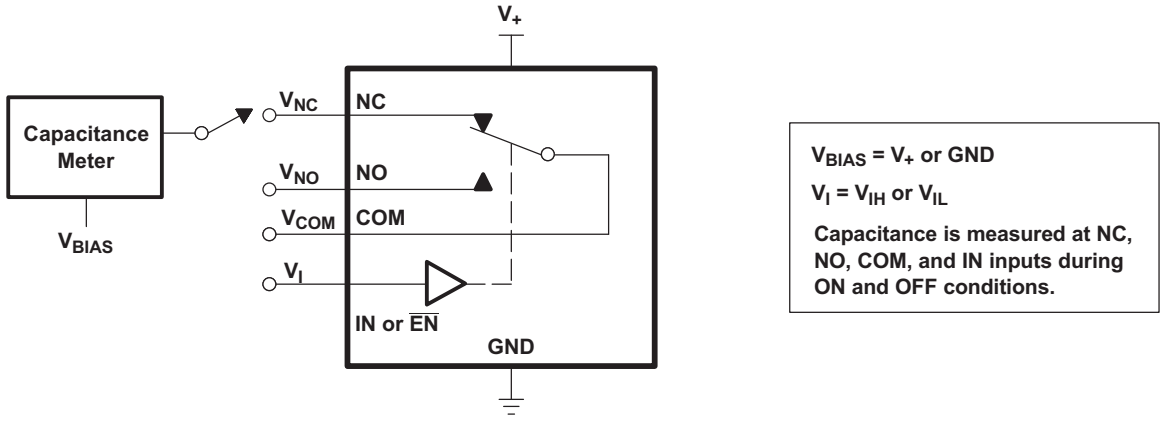
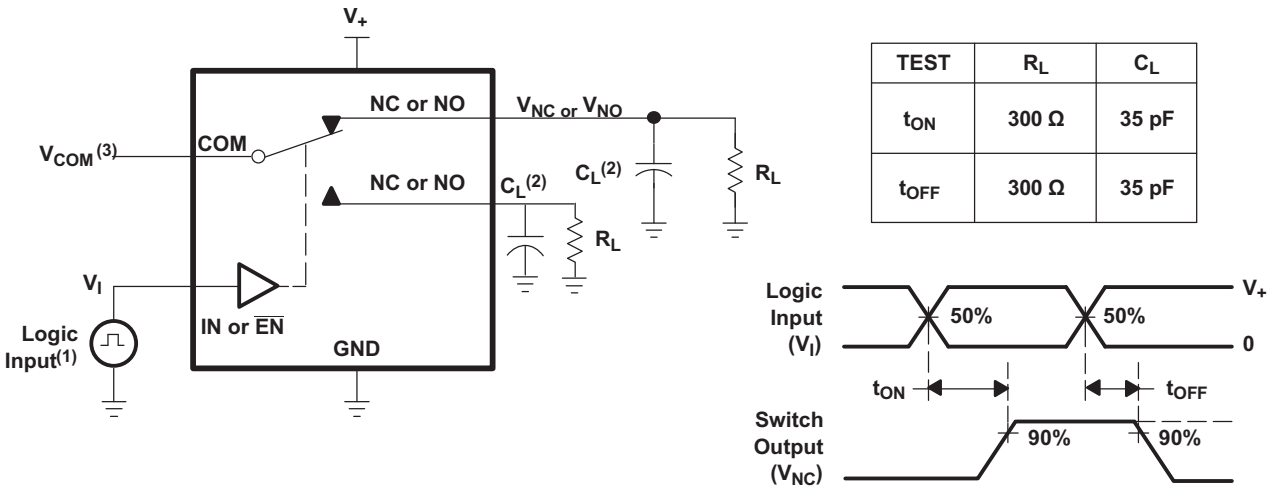


Figure 20. Capacitance (C_I, $C_{COM(OFF)}$, $C_{COM(ON)}$, $C_{NC(OFF)}$, $C_{NC(ON)}$)



TEST	R_L	C_L
t_{ON}	300 Ω	35 pF
t_{OFF}	300 Ω	35 pF

(1) All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z_O = 50 Ω, t_r < 5 ns, t_f < 5 ns.

(2) C_L includes probe and jig capacitance.

(3) See Electrical Characteristics for V_{COM}.

Figure 21. Turnon (t_{ON}) and Turnoff Time (t_{OFF})

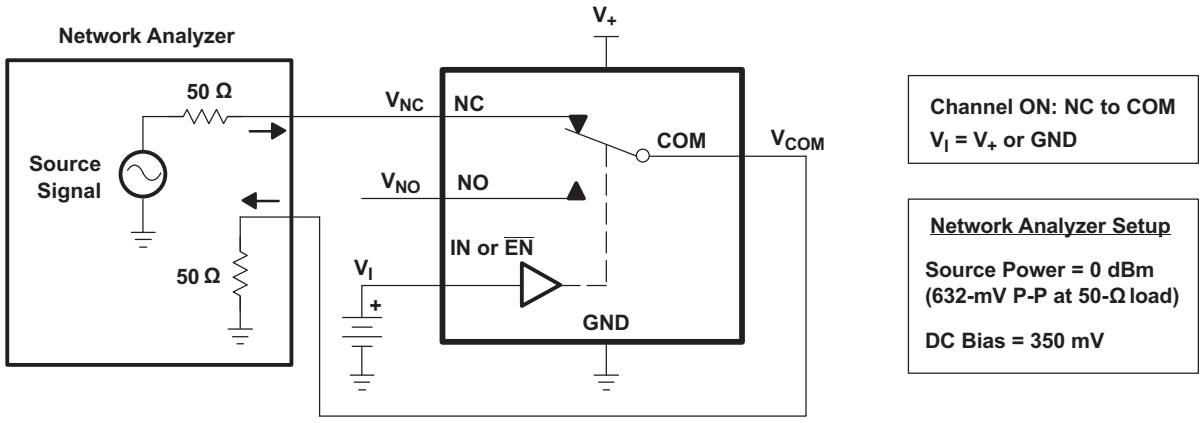
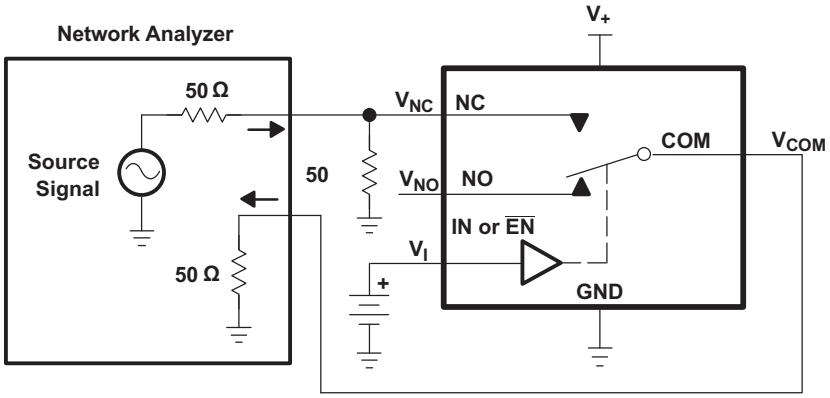


Figure 22. Bandwidth (BW)

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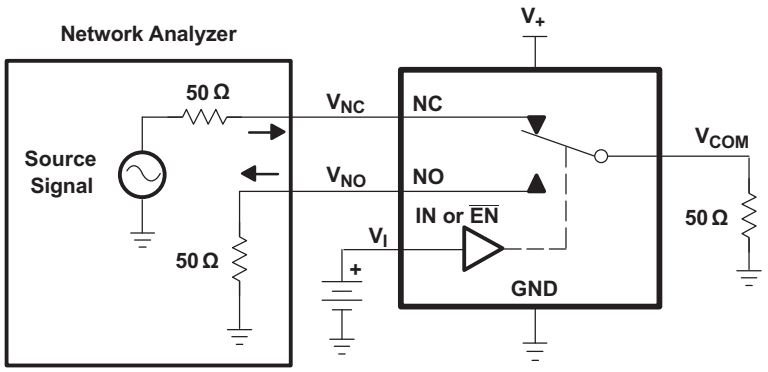
Parameter Measurement Information (continued)



Channel OFF: NC to COM
V_I = V_+ or GND

Network Analyzer Setup
Source Power = 0 dBm (632-mV P-P at 50-Ω load)
DC Bias = 350 mV

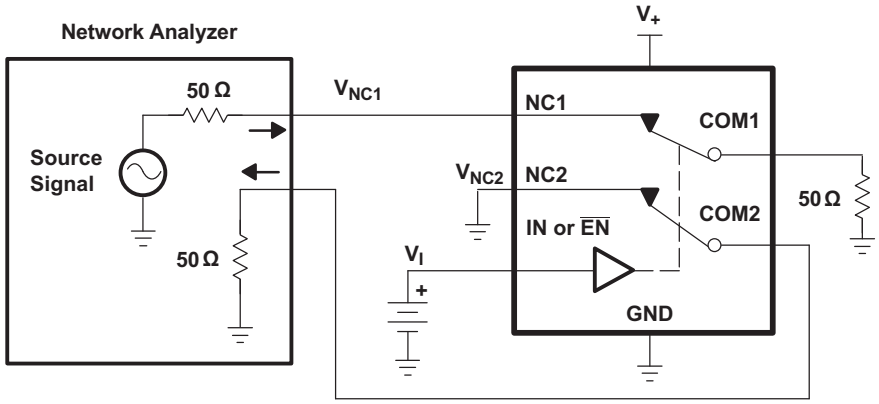
Figure 23. OFF Isolation (O_{ISO})



Channel ON: NC to COM
Channel OFF: NO to COM
V_I = V_+ or GND

Network Analyzer Setup
Source Power = 0 dBm (632-mV P-P at 50-Ω load)
DC Bias = 350 mV

Figure 24. Crosstalk (X_{TALK})



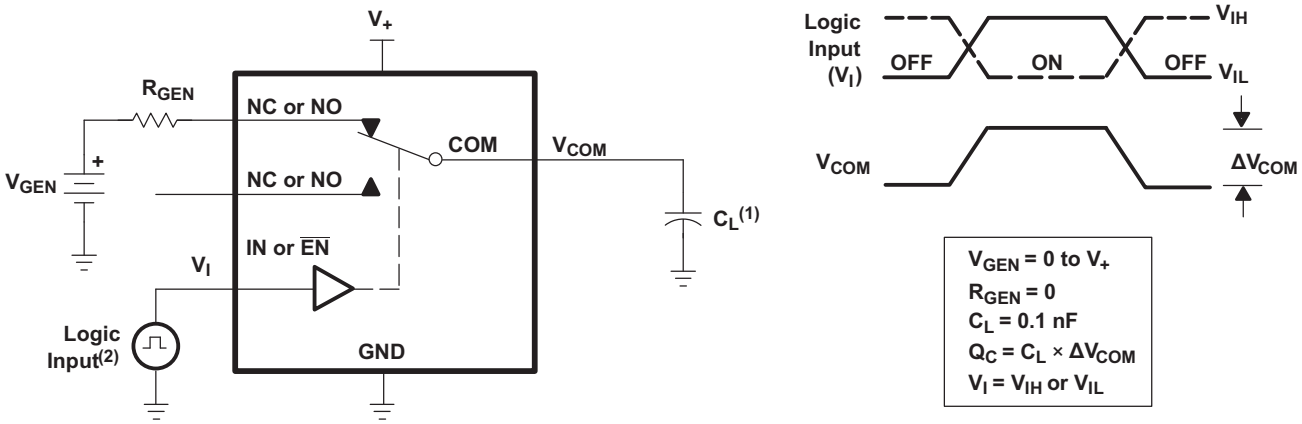
Channel ON: NC to COM

Network Analyzer Setup
Source Power = 0 dBm (632 mV P-P at 50 Ω load)
DC Bias = 350 mV

Figure 25. Crosstalk Adjacent

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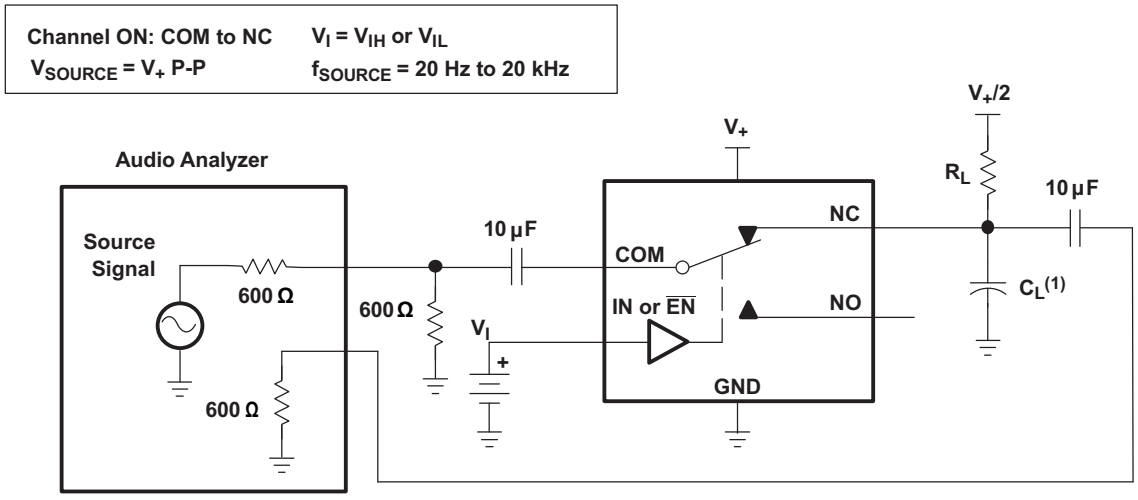
Parameter Measurement Information (continued)



(1) C_L includes probe and jig capacitance.

(2) All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z_O = 50 Ω, t_r < 5 ns, t_f < 5 ns.

Figure 26. Charge Injection (Q_C)



(1) C_L includes probe and jig capacitance.

Figure 27. Total Harmonic Distortion (THD)

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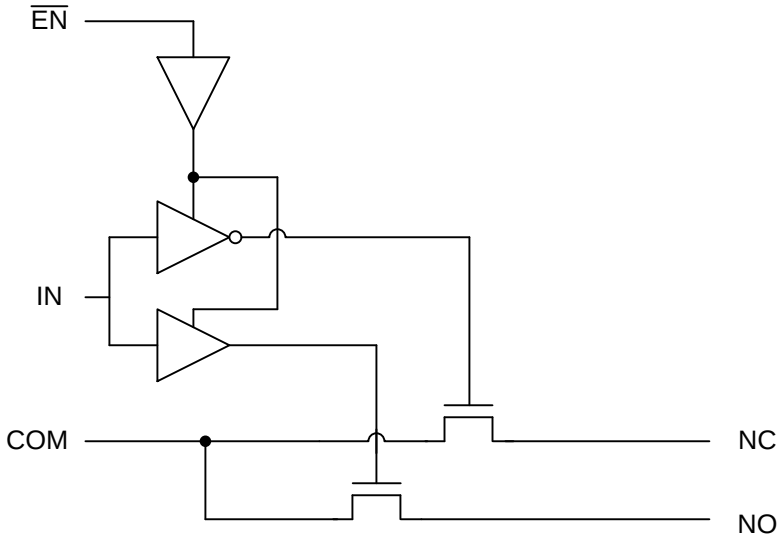
8 Detailed Description

8.1 Overview

The TS3A5018 is a quad single-pole-double-throw (SPDT) solid-state analog switch. The TS3A5018, like all analog switches, is bidirectional. When powered on, each COM pin is connected to its respective NC pin. For this device, NC stands for *normally closed* and NO stands for *normally open*. The switch is enabled when $\overline{EN}$ is low. If IN is also low, COM is connected to NC. If IN is high, COM is connected to NO.

The TS3A5018 is a break-before-make switch. This means that during switching, a connection is broken before a new connection is established. The NC and NO pins are never connected to each other.

8.2 Functional Block Diagram (Each Switch)



8.3 Feature Description

The low ON-state resistance, ON-state resistance matching, and charge injection in the TS3A5018 make this switch an excellent choice for analog signals that require minimal distortion. In addition, the low THD allows audio signals to be preserved more clearly as they pass through the device.

The 1.8-V to 3.6-V operation allows compatibility with more logic levels, and the bidirectional I/Os can pass analog signals from 0 V to V_+ with low distortion.

8.4 Device Functional Modes

Table 1. Function Table

$\overline{EN}$	IN	NO TO COM, COM TO NO	NC TO COM, COM TO NC
L	L	OFF	ON
L	H	ON	OFF
H	X	OFF	OFF

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9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The TS3A5018 can be used in a variety of customer systems. The TS3A5018 can be used anywhere multiple analog or digital signals must be selected to pass across a single line.

9.2 Typical Application

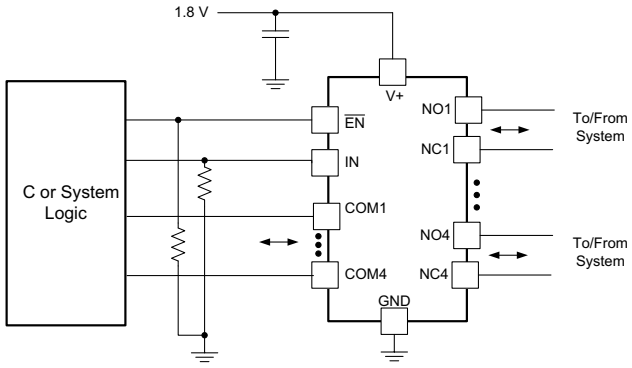


Figure 28. System Schematic for TS3A5018

9.2.1 Design Requirements

In this particular application, V_+ was 1.8 V, although V_+ is allowed to be any voltage specified in *Recommended Operating Conditions*. A decoupling capacitor is recommended on the V+ pin. See *Power Supply Recommendations* for more details.

9.2.2 Detailed Design Procedure

In this application, $\overline{EN}$ and IN are, by default, pulled low to GND. Choose these resistor sizes based on the current driving strength of the GPIO, the desired power consumption, and the switching frequency (if applicable). If the GPIO is open-drain, use pullup resistors instead.

9.2.3 Application Curve

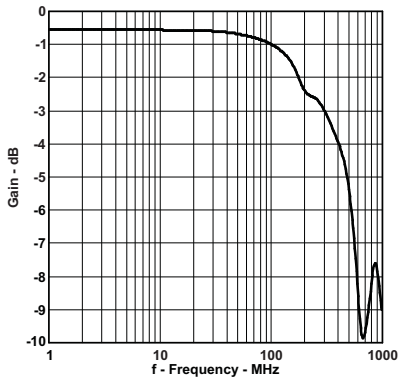


Figure 29. Gain vs Frequency Bandwidth (V_+ = 1.8 V)

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10 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*.

Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, a 0.1-μF bypass capacitor is recommended. If there are multiple pins labeled V_{CC}, then a 0.01-μF or 0.022-μF capacitor is recommended for each V_{CC} because the VCC pins will be tied together internally. For devices with dual supply pins operating at different voltages, for example V_{CC} and V_{DD}, a 0.1-μF bypass capacitor is recommended for each supply pin. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. 0.1-μF and 1-μF capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

11 Layout

11.1 Layout Guidelines

Reflections and matching are closely related to loop antenna theory, but different enough to warrant their own discussion. When a PCB trace turns a corner at a 90° angle, a reflection can occur. This is primarily due to the change of width of the trace. At the apex of the turn, the trace width is increased to 1.414 times its width. This upsets the transmission line characteristics, especially the distributed capacitance and self–inductance of the trace — resulting in the reflection. It is a given that not all PCB traces can be straight, and so they will have to turn corners. Figure 30 shows progressively better techniques of rounding corners. Only the last example maintains constant trace width and minimizes reflections.

Unused switch I/Os, such as NO, NC, and COM, can be left floating or tied to GND. However, the IN and $\overline{EN}$ pins must be driven high or low. Due to partial transistor turnon when control inputs are at threshold levels, floating control inputs can cause increased I_{CC} or unknown switch selection states.

11.2 Layout Example

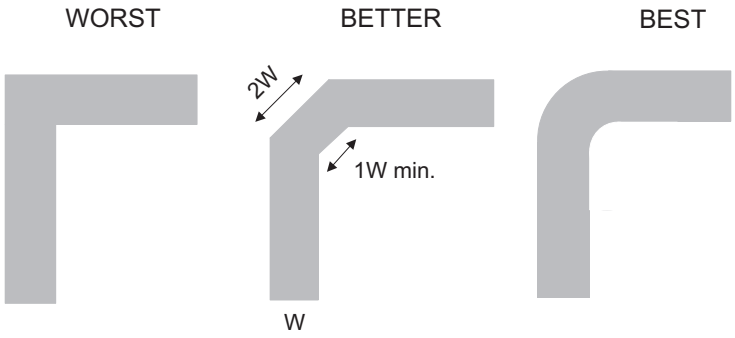


Figure 30. Trace Example

12 器件和文档支持

12.1 器件支持

12.1.1 器件命名规则

表 2. 参数 说明

符号	说明
V_{COM}	COM 处的电压
V_{NC}	NC 处的电压
V_{NO}	NO 处的电压
r_{on}	通道打开时 COM 和 NC 或 NO 端口之间的电阻
Δr_{on}	特定器件中通道间 r_{on} 的差值
$r_{on(flat)}$	额定条件范围下，同一通道内 r_{on} 最大值与最小值之间的差值
$I_{NC(OFF)}$	相应通道（NC 到 COM）处于关断状态时，在 NC 端口测得的泄漏电流
$I_{NC(ON)}$	相应通道（NC 到 COM）处于导通状态且输出 (COM) 处于开路状态时，在 NC 端口测得的泄漏电流
$I_{NO(OFF)}$	相应通道（NO 到 COM）处于关断状态时，在 NO 端口测得的泄漏电流
$I_{NO(ON)}$	相应通道（NO 到 COM）处于导通状态且输出 (COM) 处于开路状态时，在 NO 端口测得的泄漏电流
$I_{COM(OFF)}$	相应通道（COM 到 NC 或 NO）处于关断状态时，在 COM 端口测得的泄漏电流
$I_{COM(ON)}$	相应通道（COM 到 NC 或 NO）处于导通状态且输出 (NC 或 NO) 处于开路状态时，在 COM 端口测得的泄漏电流
V_{IH}	控制输入 (IN, $\overline{EN}$) 逻辑高电平的最小输入电压
V_{IL}	控制输入 (IN, $\overline{EN}$) 逻辑低电平的最大输入电压
V_I	控制输入 (IN, $\overline{EN}$) 处的电压
I_{IH}、I_{IL}	控制输入 (IN, $\overline{EN}$) 处测量的泄漏电流
t_{ON}	开关开通时间。此参数是在特定条件范围下，开关开通时，通过数字控制 (IN) 信号和模拟输出 NC 或 NO）信号之间的传播延迟测量得出。
t_{OFF}	开关关断时间。此参数是在特定条件范围下，开关开通时，通过数字控制 (OFF) 信号和模拟输出（NC 或 NO）信号之间的传播延迟测量得出。
Q_C	电荷注入是测量从控制 (IN) 输入到模拟（NC 或 NO）输入产生的不需要的信号耦合的方法。电荷注入以库仑为单位，可通过测量开关控制输入产生的总感应电荷得出该值。电荷注入，$Q_C = C_L \times \Delta V_{COM}$，$C_L$ 是负载电容，ΔV_{COM} 是模拟输出电压的变化。
$C_{NC(OFF)}$	相应通道（NC 到 COM）关闭时 NC 端口的电容
$C_{NC(ON)}$	相应通道（NC 到 COM）开启时 NC 端口的电容
$C_{NO(OFF)}$	相应通道（NO 到 COM）关闭时 NC 端口的电容
$C_{NO(ON)}$	相应通道（NO 到 COM）开启时 NC 端口的电容
$C_{COM(OFF)}$	相应通道（COM 到 NC）关闭时 COM 端口的电容
$C_{COM(ON)}$	相应通道（COM 到 NC）开启时 COM 端口的电容
C_I	控制输入 (IN, $\overline{EN}$) 电容
O_{ISO}	开关关断隔离用于衡量关断状态开关阻抗的大小。关断隔离以 dB 为单位，当相应通道（NC 到 COM）处于关断状态时，在额定频率下测量得出。
X_{TALK}	串扰是测量从开启状态的通道到关断状态的通道（NC1 到 NO1）产生的不必要信号耦合的方法。相邻串扰是测量从一条开启状态的通道到相邻开启状态的通道（NC1 到 NC2）产生的不必要信号耦合的方法。相邻串扰在额定频率下测量得出且以 dB 为单位。
BW	开关带宽。这是导通通道增益低于直流增益 -3dB 时的频率。
THD	总谐波失真用于描述由模拟开关导致的信号失真。其定义为二次、三次甚至多次谐波与基波绝对幅度之比的均方根 (RMS) 值。
I_+	静态电源电流，以及 V_+ 或 GND 的控制 (IN) 引脚

12.2 文档支持

12.2.1 相关文档

如需相关文档，请参阅：

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文档支持 **(接下页)**

- *《CMOS 输入缓慢变化或悬空的影响》*，SCBA004

12.3 接收文档更新通知

要接收文档更新通知，请导航至 TI.com.cn 上的器件产品文件夹。单击右上角的*通知我* 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

12.4 社区资源

下列链接提供到 TI 社区资源的连接。链接的内容由各个分销商“按照原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的 《使用条款》。

TI E2E™ 在线社区 ***TI 的工程师对工程师 (E2E) 社区。*** **此社区的创建目的在于促进工程师之间的协作。在 e2e.ti.com 中，您可以咨询问题、分享知识、拓展思路并与同行工程师一道帮助解决问题。**

设计支持 ***TI 参考设计支持*** **可帮助您快速查找有帮助的 E2E 论坛、设计支持工具以及技术支持的联系信息。**

12.5 商标

E2E is a trademark of Texas Instruments.
All other trademarks are the property of their respective owners.

12.6 静电放电警告

这些装置包含有限的内置 ESD 保护。 存储或装卸时，应将导线一起截短或将装置放置于导电泡棉中，以防止 MOS 门极遭受静电损伤。

12.7 术语表

SLYZ022 — *TI 术语表*。

这份术语表列出并解释术语、缩写和定义。

13 机械、封装和可订购信息

以下页面包含机械、封装和可订购信息。这些信息是指定器件的最新可用数据。数据如有变更，恕不另行通知，且不会对此文档进行修订。如需获取此数据表的浏览器版本，请参阅左侧的导航栏。

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TS3A5018D	Obsolete	Production	SOIC (D) | 16	-	-	Call TI	Call TI	-40 to 85	TS3A5018
TS3A5018DBQR	Active	Production	SSOP (DBQ) | 16	2500 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	YA018
TS3A5018DBQR.B	Active	Production	SSOP (DBQ) | 16	2500 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	YA018
TS3A5018DGVR	Active	Production	TVSOP (DGV) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	YA018
TS3A5018DGVR.B	Active	Production	TVSOP (DGV) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	YA018
TS3A5018DGVRG4	Active	Production	TVSOP (DGV) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	YA018
TS3A5018DGVRG4.B	Active	Production	TVSOP (DGV) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	YA018
TS3A5018DR	Active	Production	SOIC (D) | 16	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TS3A5018
TS3A5018DR.B	Active	Production	SOIC (D) | 16	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TS3A5018
TS3A5018DRG4	Active	Production	SOIC (D) | 16	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TS3A5018
TS3A5018DRG4.B	Active	Production	SOIC (D) | 16	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TS3A5018
TS3A5018PW	Obsolete	Production	TSSOP (PW) | 16	-	-	Call TI	Call TI	-40 to 85	YA018
TS3A5018PWR	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU | SN	Level-1-260C-UNLIM	-40 to 85	YA018
TS3A5018PWR.B	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	YA018
TS3A5018RGYR	Active	Production	VQFN (RGY) | 16	3000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	YA018
TS3A5018RGYR.B	Active	Production	VQFN (RGY) | 16	3000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	YA018
TS3A5018RGYRG4	Active	Production	VQFN (RGY) | 16	3000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	YA018
TS3A5018RGYRG4.B	Active	Production	VQFN (RGY) | 16	3000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	YA018
TS3A5018RSVR	Active	Production	UQFN (RSV) | 16	3000 | LARGE T&R	Yes	NIPDAU | NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	ZUN
TS3A5018RSVR.B	Active	Production	UQFN (RSV) | 16	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ZUN

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

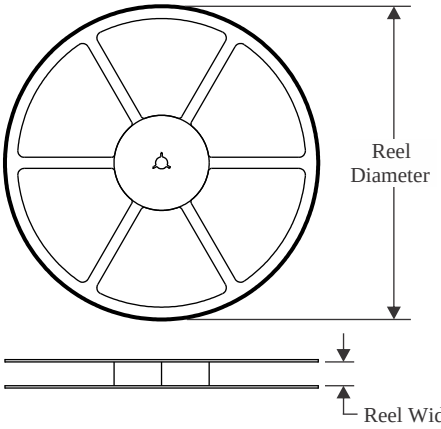
Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

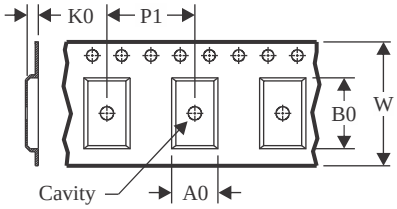
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION

REEL DIMENSIONS

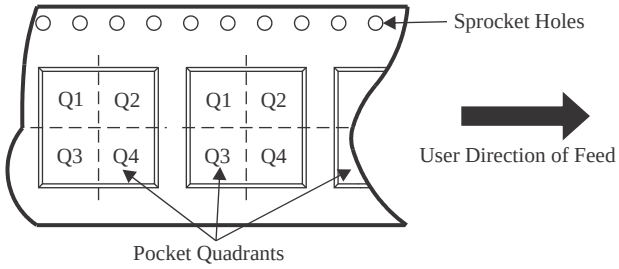


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

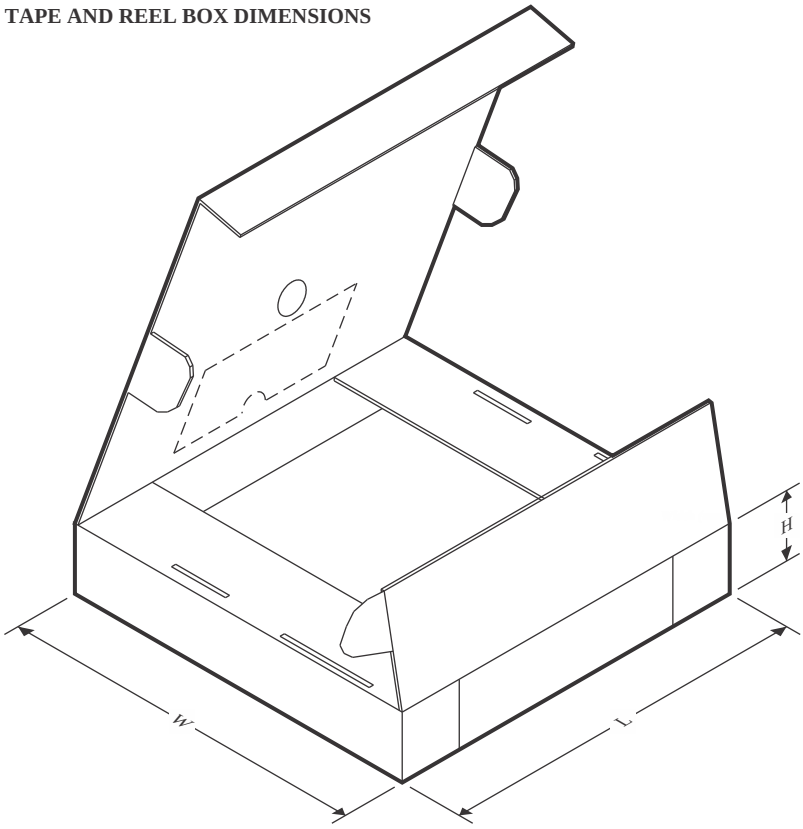
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TS3A5018DBQR	SSOP	DBQ	16	2500	330.0	12.5	6.4	5.2	2.1	8.0	12.0	Q1
TS3A5018DGVR	TVSOP	DGV	16	2000	330.0	12.4	6.8	4.0	1.6	8.0	12.0	Q1
TS3A5018DGVRG4	TVSOP	DGV	16	2000	330.0	12.4	6.8	4.0	1.6	8.0	12.0	Q1
TS3A5018DR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
TS3A5018DRG4	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
TS3A5018PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TS3A5018PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TS3A5018RGYR	VQFN	RGY	16	3000	330.0	12.4	3.8	4.3	1.5	8.0	12.0	Q1
TS3A5018RGYRG4	VQFN	RGY	16	3000	330.0	12.4	3.8	4.3	1.5	8.0	12.0	Q1
TS3A5018RSVR	UQFN	RSV	16	3000	180.0	13.2	2.1	2.9	0.75	4.0	12.0	Q1

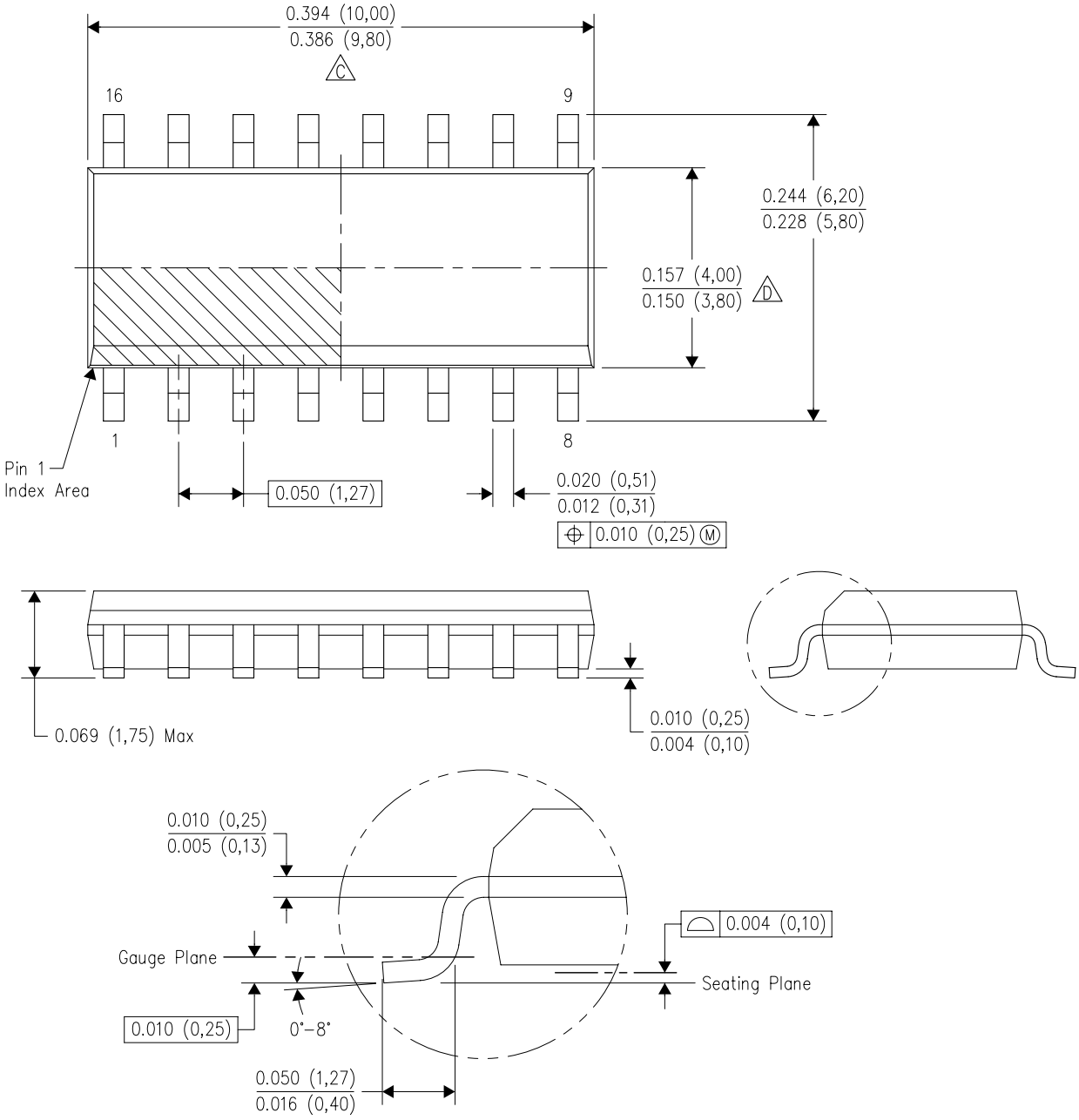
TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TS3A5018DBQR	SSOP	DBQ	16	2500	353.0	353.0	32.0
TS3A5018DGVR	TVSOP	DGV	16	2000	353.0	353.0	32.0
TS3A5018DGVRG4	TVSOP	DGV	16	2000	353.0	353.0	32.0
TS3A5018DR	SOIC	D	16	2500	353.0	353.0	32.0
TS3A5018DRG4	SOIC	D	16	2500	353.0	353.0	32.0
TS3A5018PWR	TSSOP	PW	16	2000	356.0	356.0	35.0
TS3A5018PWR	TSSOP	PW	16	2000	353.0	353.0	32.0
TS3A5018RGYR	VQFN	RGY	16	3000	353.0	353.0	32.0
TS3A5018RGYRG4	VQFN	RGY	16	3000	353.0	353.0	32.0
TS3A5018RSVR	UQFN	RSV	16	3000	184.0	184.0	19.0

D (R–PDSO–G16) PLASTIC SMALL OUTLINE



NOTES:
A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
D. Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
E. Reference JEDEC MS–012 variation AC.

GENERIC PACKAGE VIEW

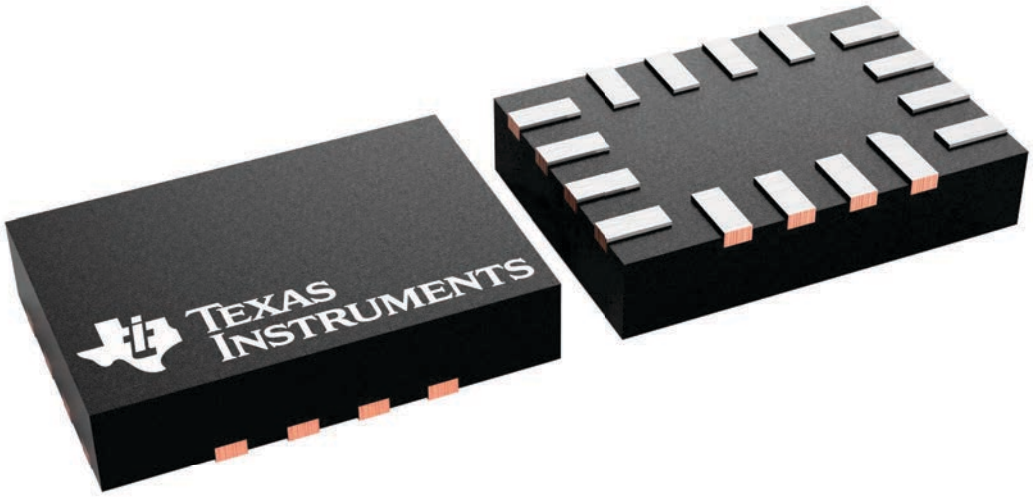
RSV 16

UQFN - 0.55 mm max height

1.8 x 2.6, 0.4 mm pitch

ULTRA THIN QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



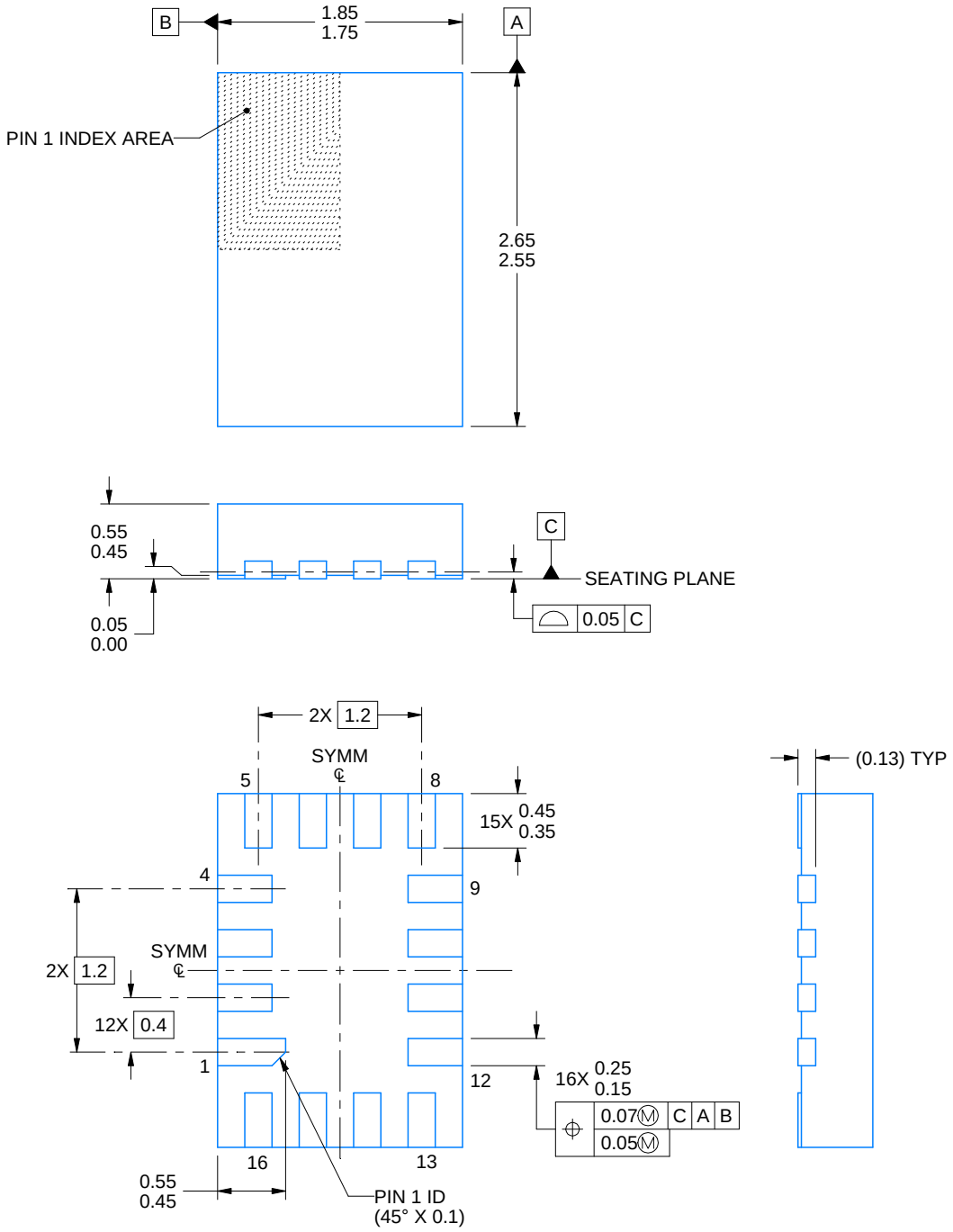
4231225/A

RSV0016A

PACKAGE OUTLINE

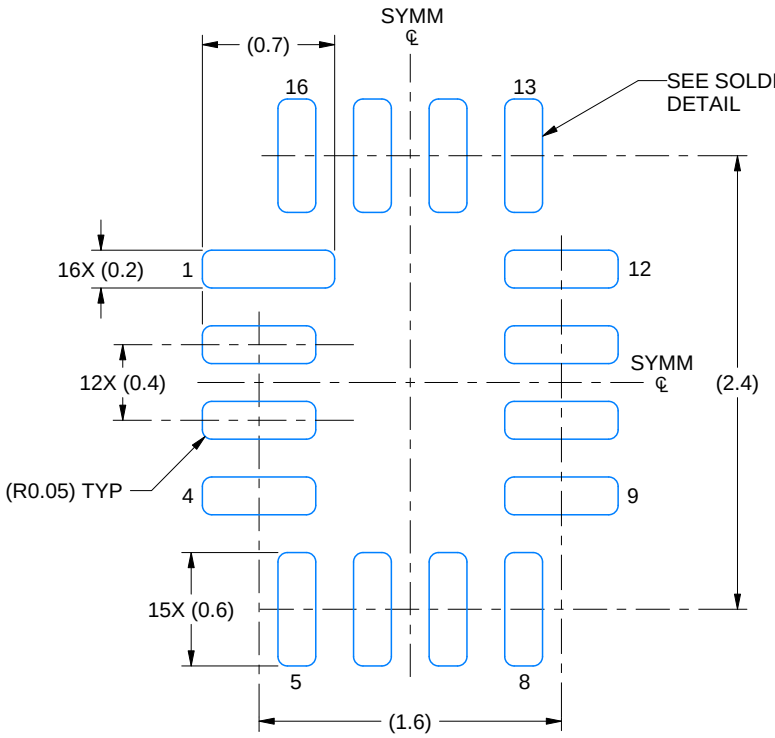
UQFN - 0.55 mm max height

ULTRA THIN QUAD FLATPACK - NO LEAD

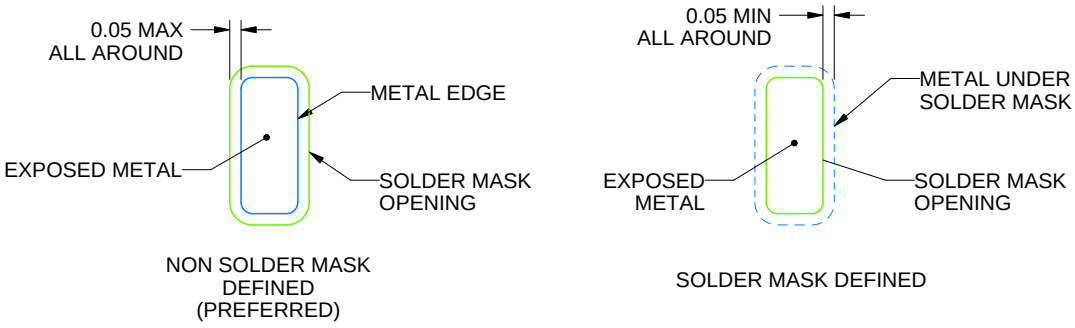


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 25X

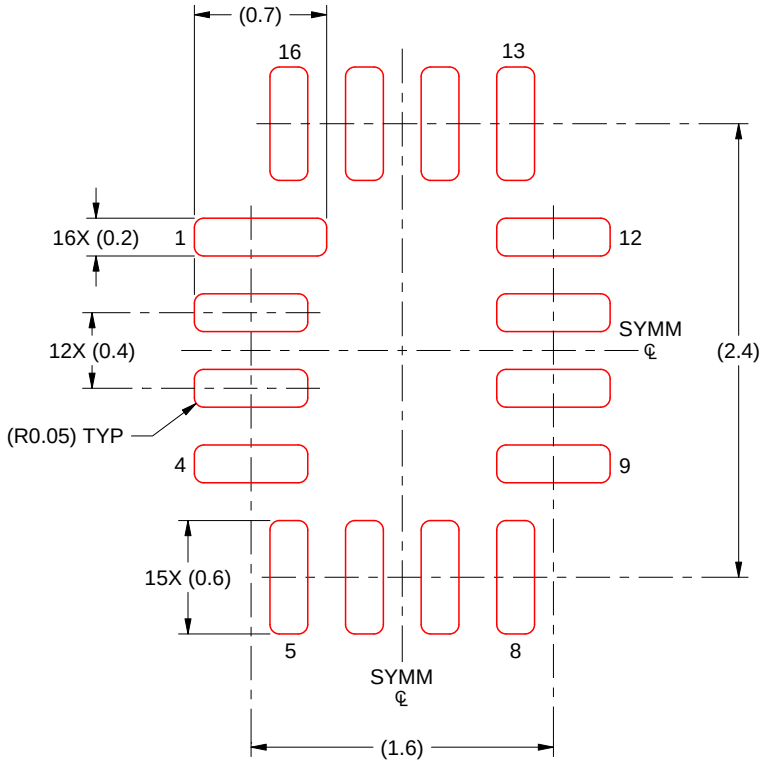


SOLDER MASK DETAILS

4220314/C 02/2020

NOTES: (continued)

3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).



SOLDER PASTE EXAMPLE
BASED ON 0.125 MM THICK STENCIL
SCALE: 25X

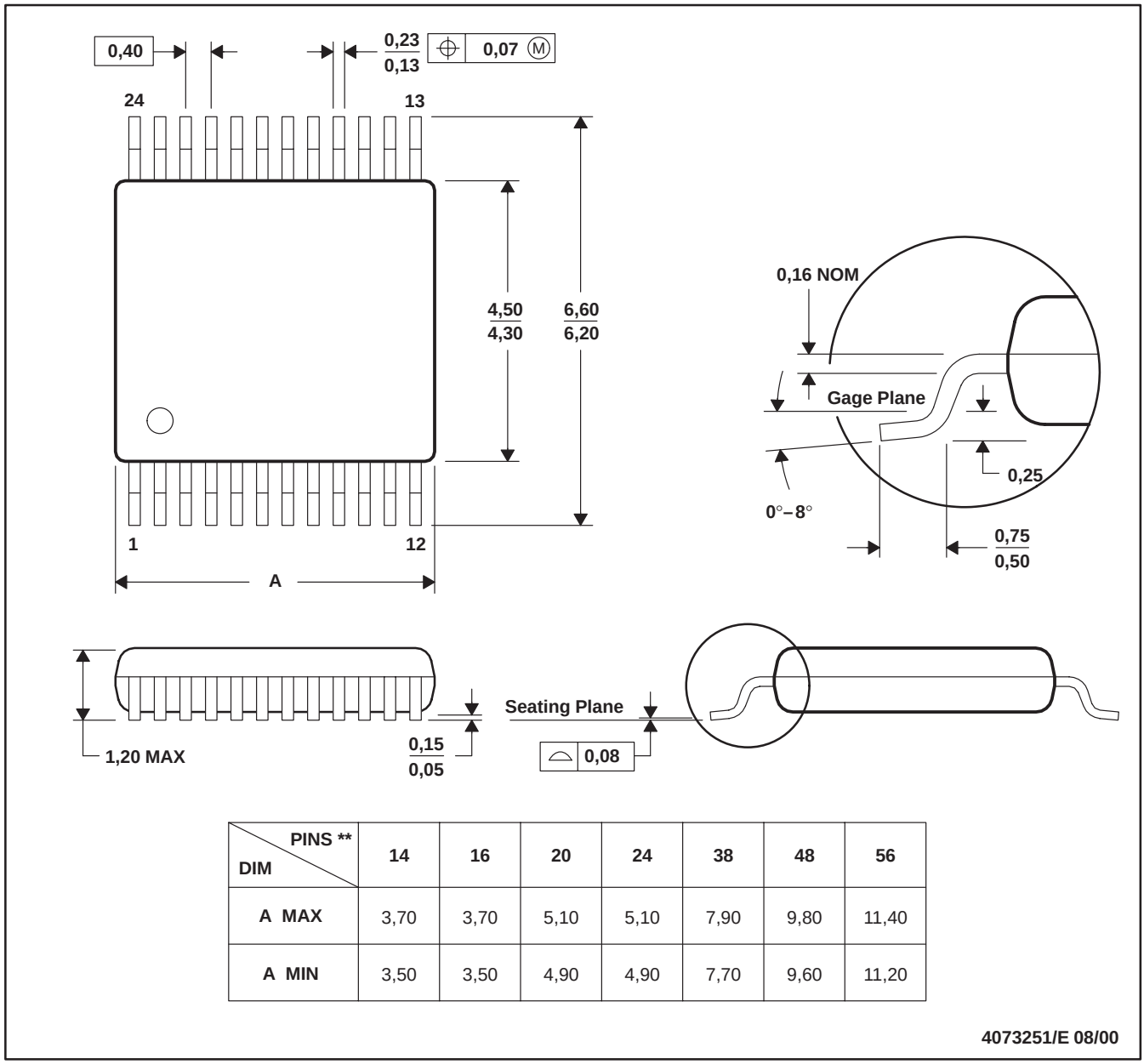
4220314/C 02/2020

NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

DGV (R-PDSO-G)** **PLASTIC SMALL-OUTLINE**

24 PINS SHOWN



DIM \ PINS **	14	16	20	24	38	48	56
A MAX	3,70	3,70	5,10	5,10	7,90	9,80	11,40
A MIN	3,50	3,50	4,90	4,90	7,70	9,60	11,20

4073251/E 08/00

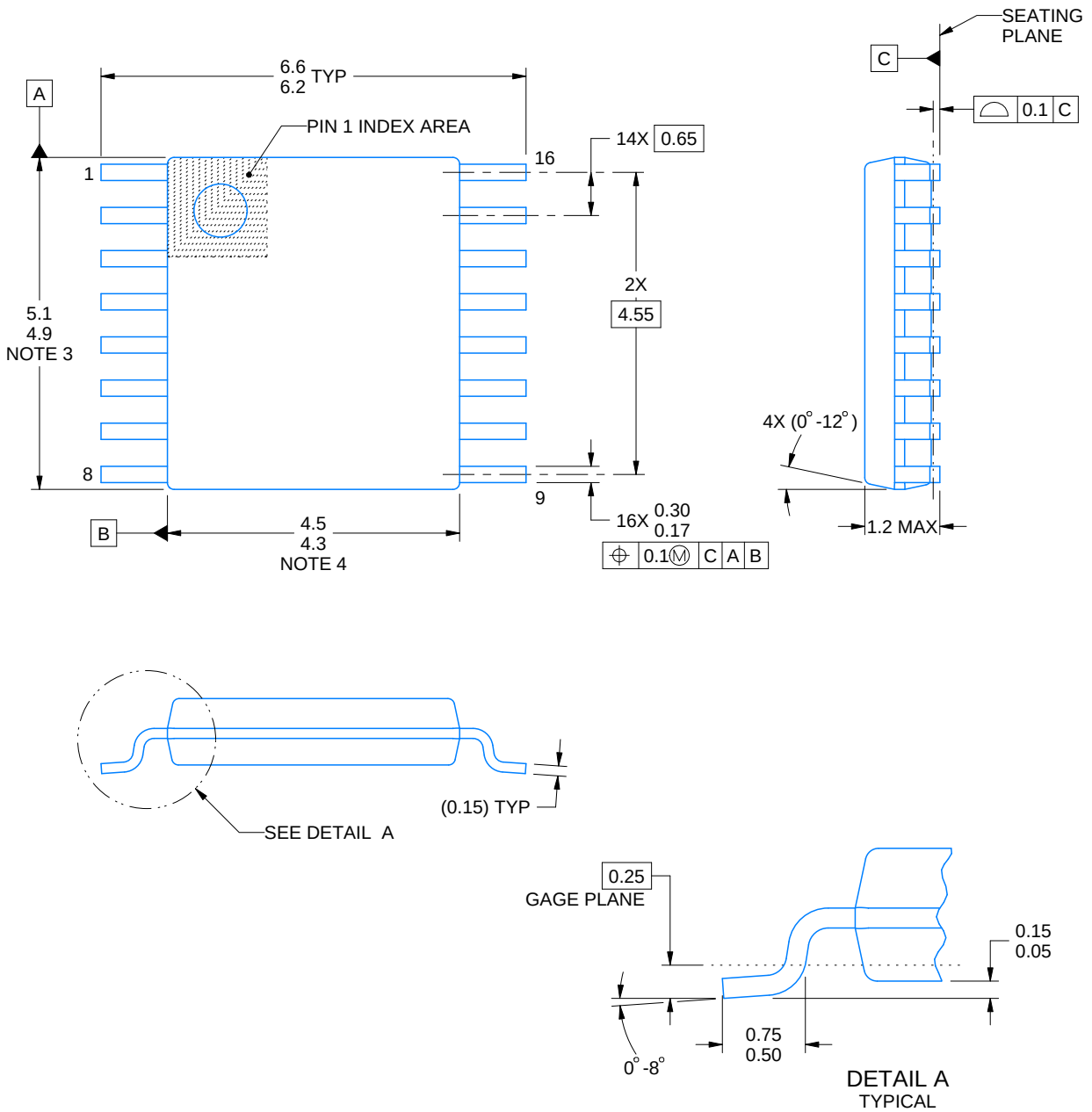
NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
D. Falls within JEDEC: 24/48 Pins – MO-153
14/16/20/56 Pins – MO-194

PACKAGE OUTLINE

PW0016A

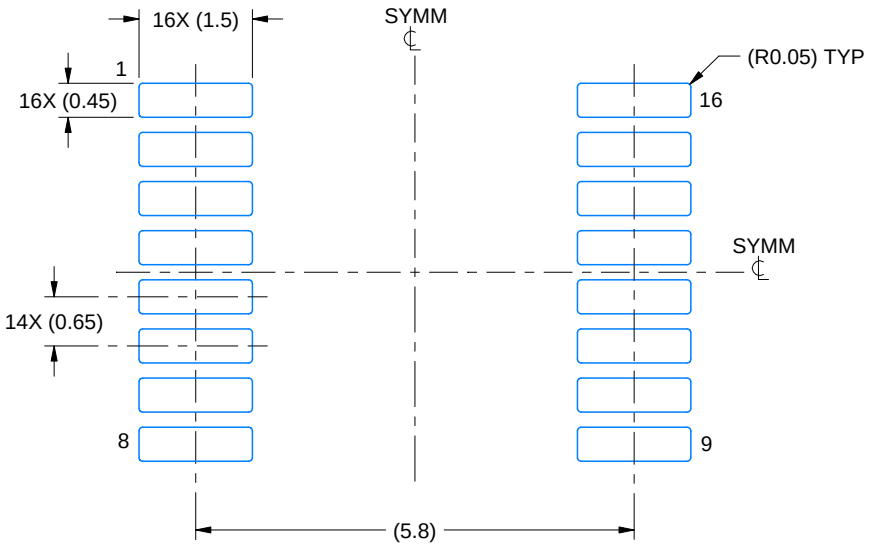
TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X

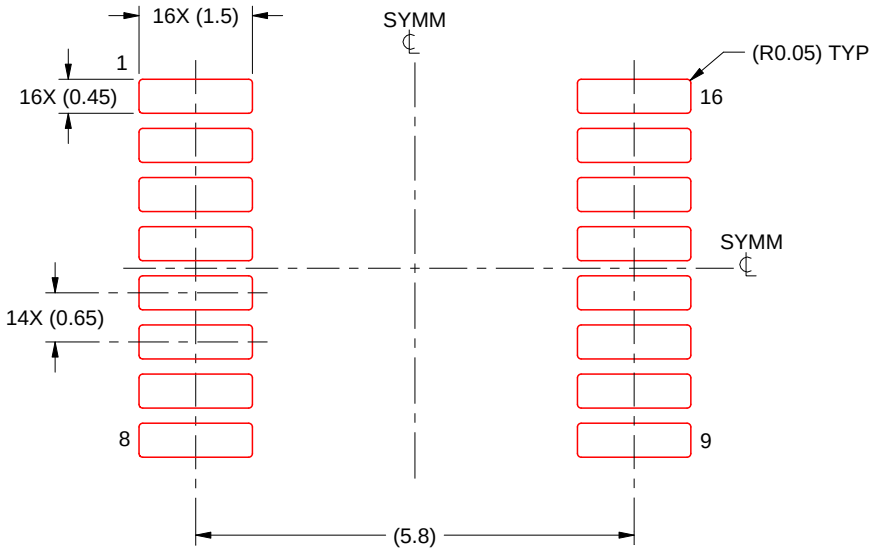


SOLDER MASK DETAILS

4220204/B 12/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

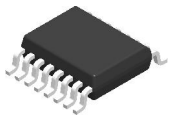


SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220204/B 12/2023

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

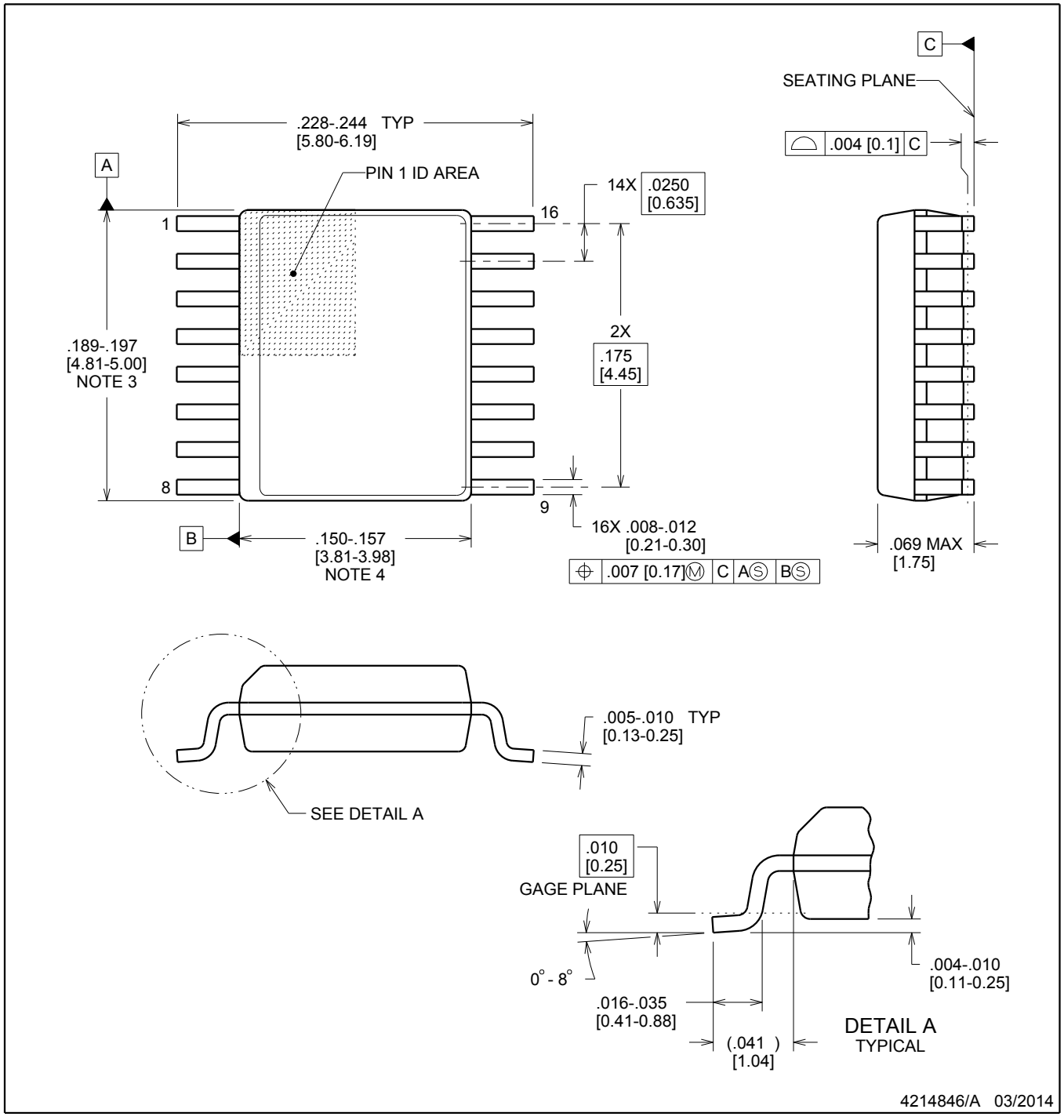


PACKAGE OUTLINE

DBQ0016A

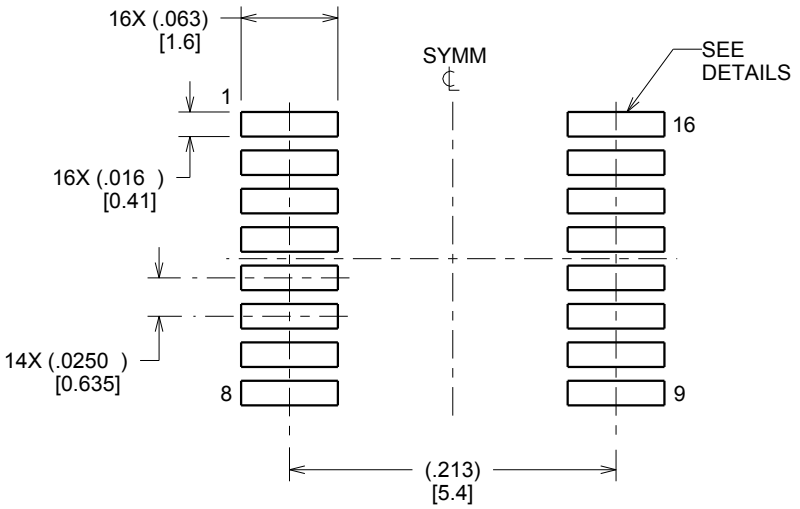
SSOP - 1.75 mm max height

SHRINK SMALL-OUTLINE PACKAGE

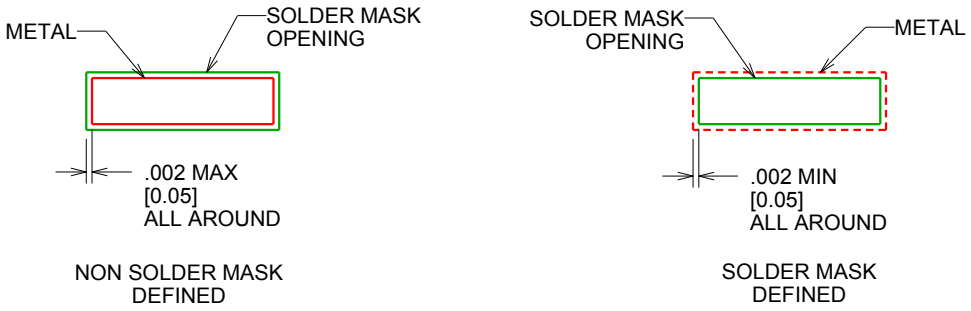


NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 inch, per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MO-137, variation AB.



LAND PATTERN EXAMPLE
SCALE:8X



SOLDER MASK DETAILS

4214846/A 03/2014

NOTES: (continued)

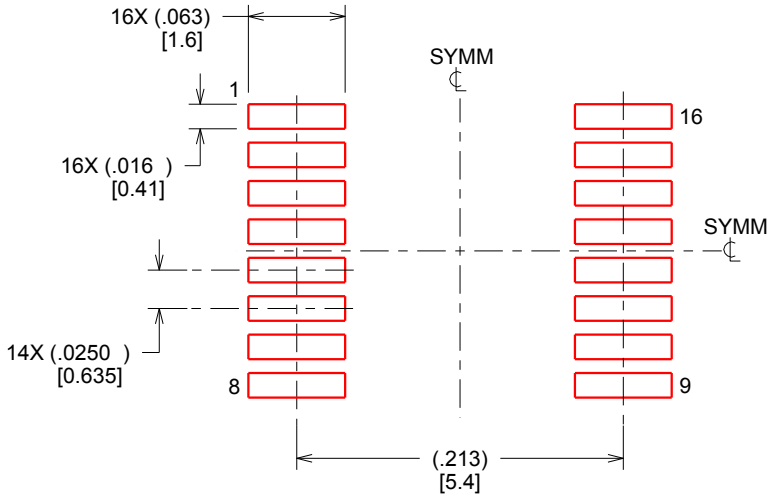
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DBQ0016A

SSOP - 1.75 mm max height

SHRINK SMALL-OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.127 MM] THICK STENCIL
SCALE:8X

4214846/A 03/2014

NOTES: (continued)

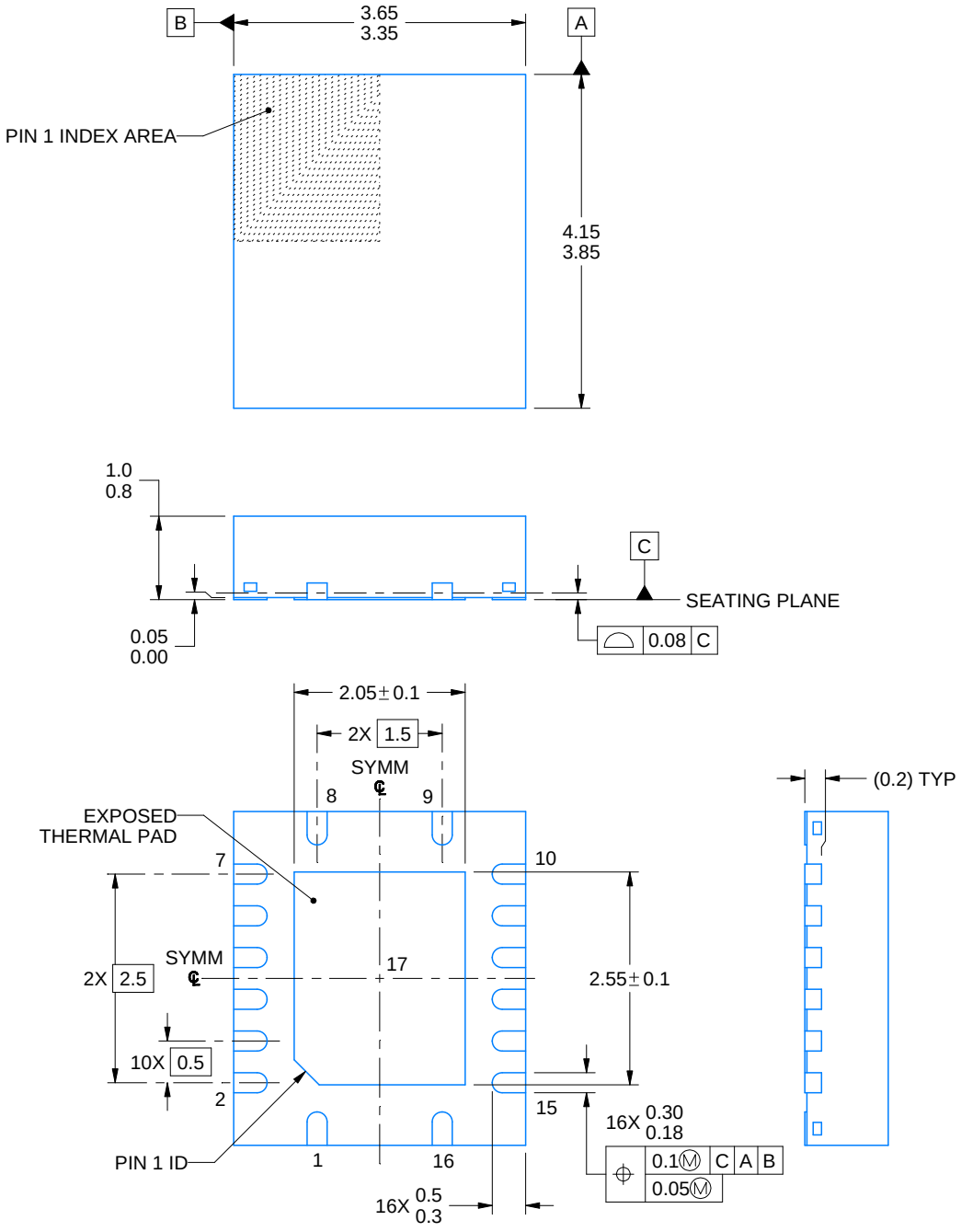
8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

RGY0016A

PACKAGE OUTLINE

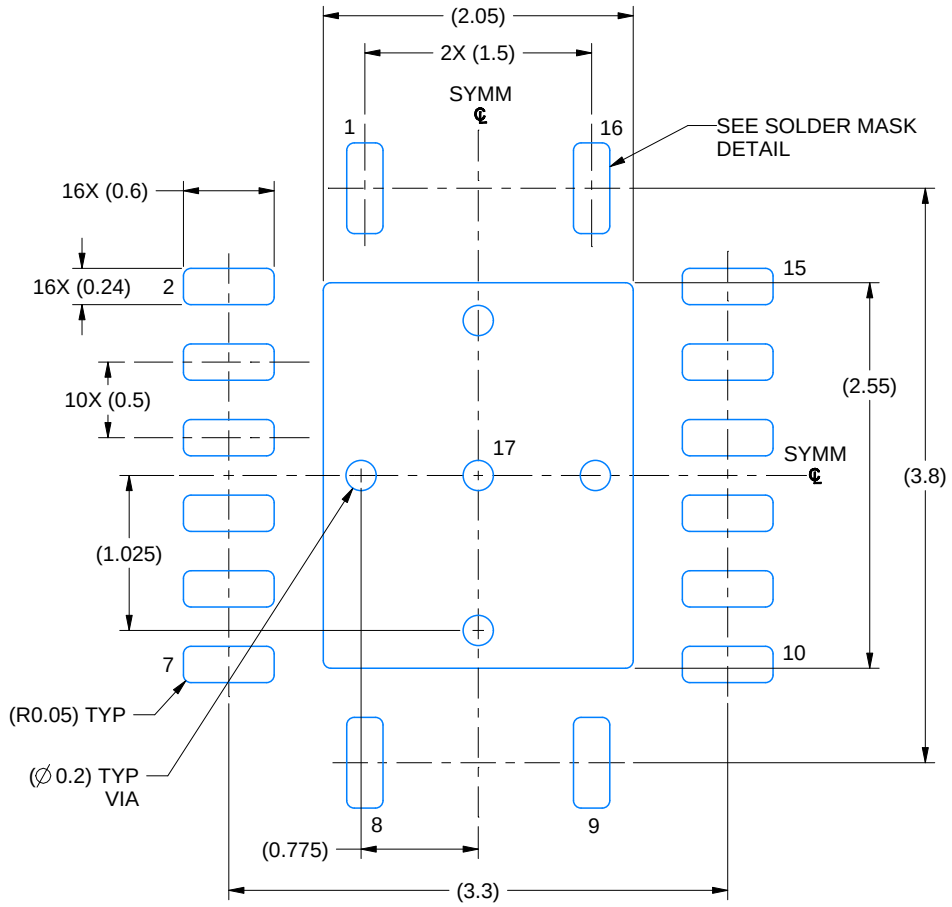
VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD

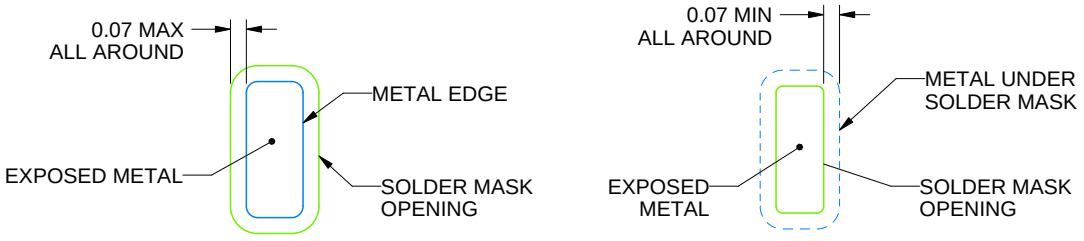


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 20X

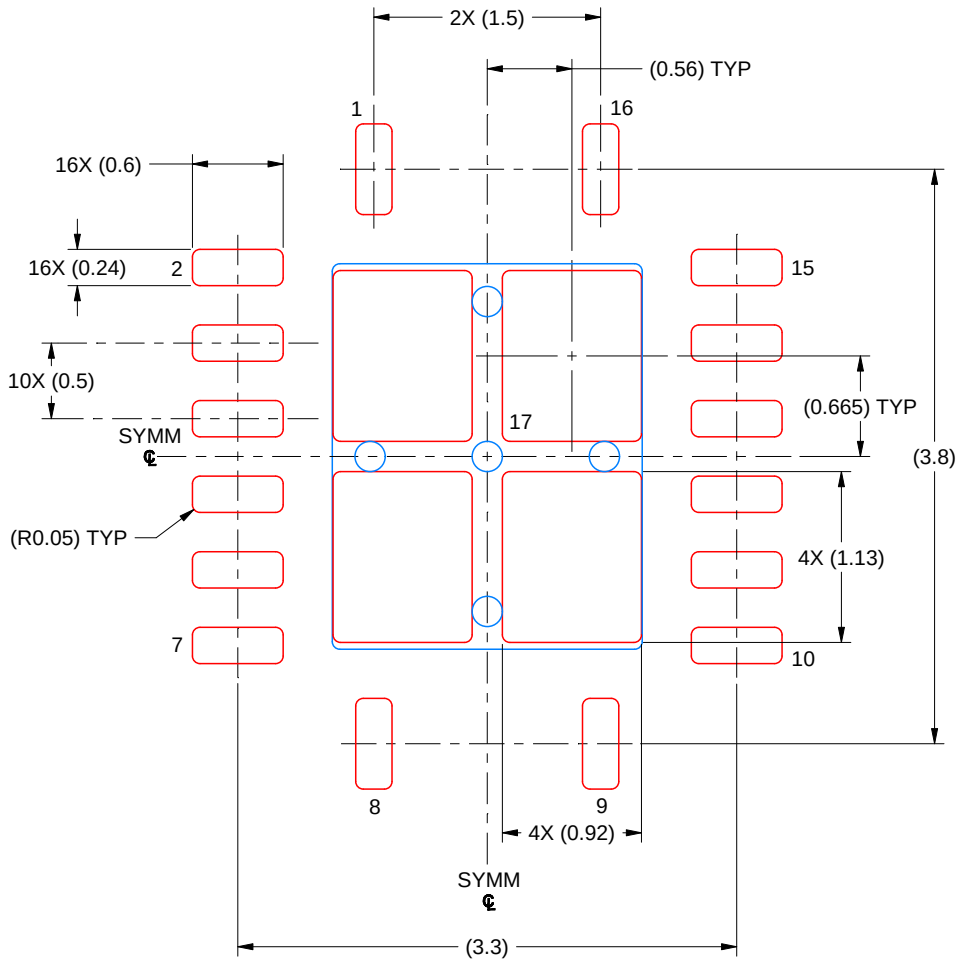


SOLDER MASK DETAILS

4225140/A 07/2019

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



SOLDER PASTE EXAMPLE
BASED ON 0.125 MM THICK STENCIL
SCALE: 20X

EXPOSED PAD 17
80% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE

4225140/A 07/2019

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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